Document Title

4M X 8 Bit / 2M X 16 Bit CMOS 3.0 Volt-only, Boot Sector Flash Memory

Revision History

Rev. No.	History	Issue Date	Remark
0.0	Initial issue	April 12, 2006	Preliminary
0.1	Error correction: Top/Bottom device ID code and pin configurations	May 25, 2006	
0.2	Change Table1 & Program/Erasure time	July 3, 2006	
1.0	Final version release	January 5, 2007	Final
1.1	Modify symbol "L" outline dimensions in TSOP 48L package	November 15, 2007	
1.2	Modify Figure 2-1 and Figure 2-2	August 18, 2008	
	Modify t_{WHWH1} and t_{WHWH2}		
	Modify V_{HH} and V_{ID}		
1.3	Modify A29L320A top block sector 34 address	December 12, 2008	
1.4	Update VCC supply voltages for extended range devices (-I/-U)	April 3, 2009	
	Modify the $\overline{WP}$ /ACC operation of write in Table 1		
1.5	Remove non Pb-free package type	February 8, 2010	
1.6	Page 1: Change from typical 100,000 cycles to minimum 100,000 cycles	November 25, 2010	
1.7	Page 19: CFI query data change from 0001h to 0004h at address 8Eh	November 23, 2012	
	CFI query data change from 0085h to 00B5h at address 9Ah		
	CFI query data change from 0095h to 00C5h at address 9Ch		

A29L320A Series

4M X 8 Bit / 2M X 16 Bit CMOS 3.0 Volt-only, Boot Sector Flash Memory

Features

- Single power supply operation
  - Regulated voltage range of commercial devices: 2.7 to 3.6 volt read and write operations for compatibility with high performance 3 volt microprocessors
  - Regulated voltage range of extended range devices: 3.0 to 3.6 volt read and write operations for compatibility with high performance 3 volt microprocessors
- Access times:
  - 70/80/90/120 (max.)
- Current:
  - 2mA active read current at 1MHz
  - 10mA active read current at 5MHz
  - 20 mA typical program/erase current
  - 500 nA typical CMOS standby or Automatic Sleep Mode current
- Flexible sector architecture
  - Eight 8 Kbyte sectors
  - Sixty-three 64 kbyte sectors
  - Any combination of sectors can be erased
  - Supports full chip erase
  - Sector protection:
- Unlock Bypass Program Command
  - Reduces overall programming time when issuing multiple program command sequence
- Top or bottom boot block configurations available
- Embedded Algorithms
  - Embedded Erase algorithm will automatically erase the entire chip or any combination of designated sectors and verify the erased sectors
- Embedded Program algorithm automatically writes and verifies data at specified addresses
- Minimum 100,000 program/erase cycles per sector
- 20-year data retention at 125°C
  - Reliable operation for the life of the system
- CFI (Common Flash Interface) compliant

- Provides device-specific information to the system, allowing host software to easily reconfigure for different Flash devices
- Compatible with JEDEC-standards
  - Pinout and software compatible with single-power-supply Flash memory standard
  - Superior inadvertent write protection
- $\overline{Data}$ Polling and toggle bits
  - Provides a software method of detecting completion of program or erase operations
- Ready / $\overline{BUSY}$ pin (RY / $\overline{BY}$)
  - Provides a hardware method of detecting completion of program or erase operations
- Erase Suspend/Erase Resume
  - Suspends a sector erase operation to read data from, or program data to, a non-erasing sector, then resumes the erase operation
- Hardware reset pin ($\overline{RESET}$)
  - Hardware method to reset the device to reading array data
- $\overline{WP}$ /ACC input pin
  - Write protect ($\overline{WP}$) function allows protection of two outermost boot sectors, regardless of sector protect status
  - Acceleration (ACC) function provides accelerated program times
- Hardware/Software temporary sector block unprotect command allows code changes in previously locked sectors
- Hardware/Software sector protect/unprotect command
- Package options
  - 48-pin TSOP (I) or 48-ball TFBGA
  - All Pb-free (Lead-free) products are RoHS compliant

General Description

The A29L320A is a 32Mbit, 3.3 volt-only Flash memory organized as 2,097,152 words of 16 bits or 4,194,304 bytes of 8 bits each. The 8 bits of data appear on I/O0 - I/O7; the 16 bits of data appear on I/O0~I/O15. The A29L320A is offered in 48-ball TFBGA and 48-Pin TSOP packages. This device is designed to be programmed in-system with the standard system 3.3 volt VCC supply. Additional 12.0 volt VPP is not required for in-system write or erase operations. However, the A29L320A can also be programmed in standard EPROM programmers.

The A29L320A has the first toggle bit, I/O6, which indicates whether an Embedded Program or Erase is in progress, or it is in the Erase Suspend. Besides the I/O6 toggle bit, the A29L320A has a second toggle bit, I/O2, to indicate whether the addressed sector is being selected for erase. The

A29L320A also offers the ability to program in the Erase Suspend mode. The standard A29L320A offers access times of 70,80,90 and 120ns, allowing high-speed microprocessors to operate without wait states. To eliminate bus contention the device has separate chip enable ($\overline{CE}$), write enable ($\overline{WE}$) and output enable ($\overline{OE}$) controls.

The device requires only a single 3.3 volt power supply for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

The A29L320A is entirely software command set compatible with the JEDEC single-power-supply Flash standard. Commands are written to the command register using standard microprocessor write timings. Register contents

serve as input to an internal state-machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by writing the proper program command sequence. This initiates the Embedded Program algorithm - an internal algorithm that automatically times the program pulse widths and verifies proper program margin.

Device erasure occurs by executing the proper erase command sequence. This initiates the Embedded Erase algorithm - an internal algorithm that automatically preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper erase margin. The Unlock Bypass mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

The host system can detect whether a program or erase operation is complete by observing the RY / $\overline{BY}$ pin, or by reading the I/O$_7$ ($\overline{Data}$ Polling) and I/O$_6$ (toggle) status bits. After a program or erase cycle has been completed, the device is ready to read array data or accept another command.

The sector erase architecture allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The A29L320A is fully erased when shipped from the factory.

The hardware sector protection feature disables operations for both program and erase in any combination of the sectors of memory. This can be achieved via programming equipment.
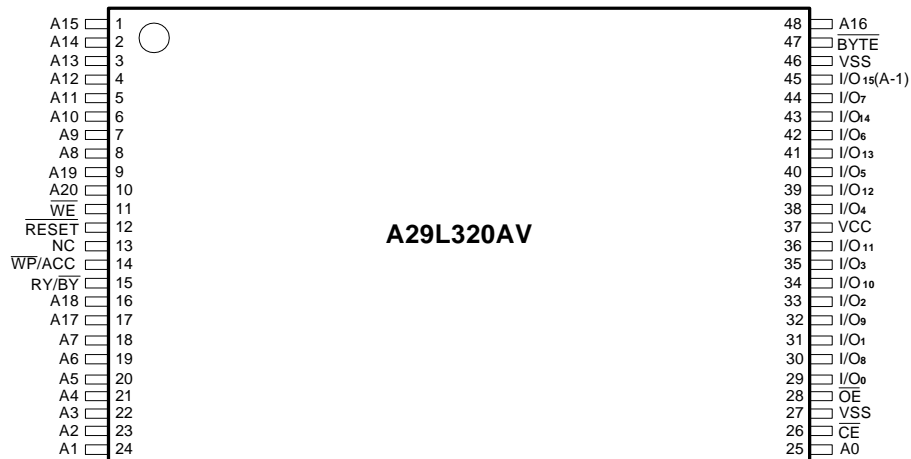
The Erase Suspend/Erase Resume feature enables the user to put erase on hold for any period of time to read data from, or program data to, any other sector that is not selected for erasure. True background erase can thus be achieved.
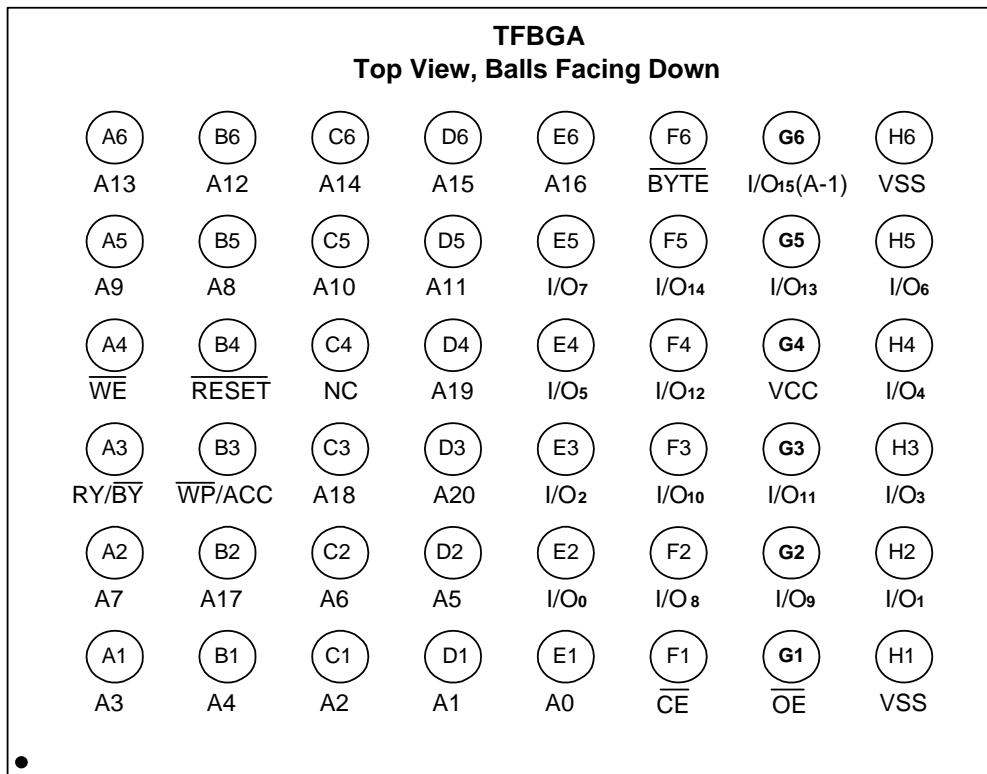
The hardware $\overline{RESET}$ pin terminates any operation in progress and resets the internal state machine to reading array data. The $\overline{RESET}$ pin may be tied to the system reset circuitry. A system reset would thus also reset the device, enabling the system microprocessor to read the boot-up firmware from the Flash memory.
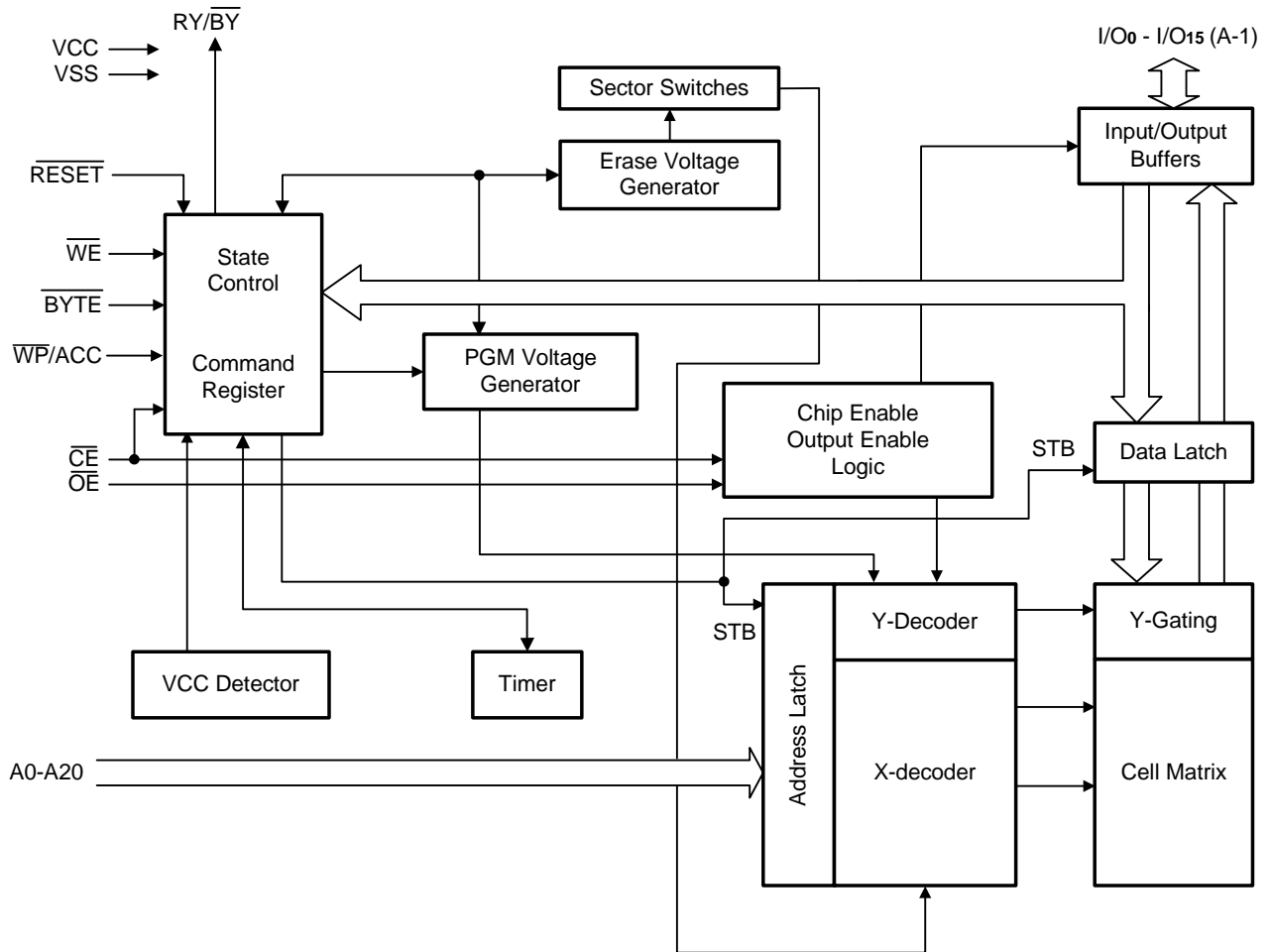
The device offers two power-saving features. When addresses have been stable for a specified amount of time, the device enters the automatic sleep mode. The system can also place the device into the standby mode. Power consumption is greatly reduced in both these modes.

Pin Configurations

■ TSOP (I)

Pin Configurations (continued)

■ **TFBGA**

TFBGA
Top View, Balls Facing Down

A6	B6	C6	D6	E6	F6	**G6**	H6
A13	A12	A14	A15	A16	$\overline{BYTE}$	I/O$_{15}$(A-1)	VSS
A5	B5	C5	D5	E5	F5	**G5**	H5
A9	A8	A10	A11	I/O$_7$	I/O$_{14}$	I/O$_{13}$	I/O$_6$
A4	B4	C4	D4	E4	F4	**G4**	H4
$\overline{WE}$	$\overline{RESET}$	NC	A19	I/O$_5$	I/O$_{12}$	VCC	I/O$_4$
A3	B3	C3	D3	E3	F3	**G3**	H3
RY/$\overline{BY}$	$\overline{WP}$/ACC	A18	A20	I/O$_2$	I/O$_{10}$	I/O$_{11}$	I/O$_3$
A2	B2	C2	D2	E2	F2	**G2**	H2
A7	A17	A6	A5	I/O$_0$	I/O$_8$	I/O$_9$	I/O$_1$
A1	B1	C1	D1	E1	F1	**G1**	H1
A3	A4	A2	A1	A0	$\overline{CE}$	$\overline{OE}$	VSS

Block Diagram

Pin Descriptions

Pin No.		Description
A0 - A20		Address Inputs
I/O$_0$ - I/O$_{14}$		Data Inputs/Outputs
I/O$_{15}$ (A-1)	I/O$_{15}$	Data Input/Output, Word Mode
	A-1	LSB Address Input, Byte Mode
$\overline{CE}$		Chip Enable
$\overline{WE}$		Write Enable
$\overline{OE}$		Output Enable
$\overline{RESET}$		Hardware Reset
$\overline{BYTE}$		Selects Byte Mode or Word Mode
RY/$\overline{BY}$		Ready/$\overline{BUSY}$ - Output
VSS		Ground
VCC		Power Supply
NC		Pin not connected internally
$\overline{WP}$ /ACC		Hardware Write Protect / Acceleration Pin

Absolute Maximum Ratings*

Storage Temperature Plastic Packages. . . -65°C to + 150°C
Ambient Temperature with Power Applied. -55°C to + 125°C
Voltage with Respect to Ground
VCC (Note 1) . . . . -0.5V to +4.0V
A9, $\overline{\text{OE}}$ & $\overline{\text{RESET}}$ (Note 2) . . . . -0.5V to +12.5V
$\overline{\text{WP}}$/ACC . . . . -0.5V to +12.5V
All other pins (Note 1) . . . . -0.5V to VCC + 0.5V
Output Short Circuit Current (Note 3) 200mA

Notes:

1. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, input or I/O pins may undershoot VSS to -2.0V for periods of up to 20ns. Maximum DC voltage on input and I/O pins is VCC +0.5V. During voltage transitions, input or I/O pins may overshoot to VCC +2.0V for periods up to 20ns.

2. Minimum DC input voltage on A9, $\overline{\text{OE}}$ and $\overline{\text{RESET}}$ is -0.5V. During voltage transitions, A9, $\overline{\text{OE}}$ and $\overline{\text{RESET}}$ may overshoot VSS to -2.0V for periods of up to 20ns. Maximum DC input voltage on A9 is +12.5V which may overshoot to 14.0V for periods up to 20ns.

3. No more than one output is shorted at a time. Duration of the short circuit should not be greater than one second.

Device Bus Operations

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is composed of latches that store the commands, along with the address and data information needed to execute the

*Comments

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to this device. These are stress ratings only. Functional operation of this device at these or any other conditions above those indicated in the operational sections of these specification is not implied or intended. Exposure to the absolute maximum rating conditions for extended periods may affect device reliability.

Operating Ranges

Commercial (C) Devices

Ambient Temperature (T$_A$) . . . . 0°C to +70°C

Extended Range Devices

Ambient Temperature (T$_A$)
For –U series . . . . -40°C to +85°C
For –I series . . . . -25°C to +85°C

VCC Supply Voltages

VCC for commercial devices . . . . +2.7V to +3.6V
VCC for extended range devices . . . . +3.0V to +3.6V
Operating ranges define those limits between which the functionally of the device is guaranteed.

command. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. The appropriate device bus operations table lists the inputs and control levels required, and the resulting output. The following subsections describe each of these operations in further detail.

Table 1. A29L320A Device Bus Operations

Operation	$\overline{\text{CE}}$	$\overline{\text{OE}}$	$\overline{\text{WE}}$	$\overline{\text{RESET}}$	$\overline{\text{WP}}$/ ACC	A0 - A20 (Note 1)	I/O$_0$ - I/O$_7$	I/O$_8$ - I/O$_{15}$	
								$\overline{\text{BYTE}}$ =V$_{IH}$	$\overline{\text{BYTE}}$ =V$_{IL}$
Read	L	L	H	H	L/H	A$_{IN}$	D$_{OUT}$	D$_{OUT}$	I/O$_8$~I/O$_{14}$=High-Z
Write	L	H	L	H	L/H (Note 3)	A$_{IN}$	(Note 4)	(Note 4)	I/O$_{15}$=A$_{-1}$
Accelerated Program	L	H	L	H	V$_{HH}$	A$_{IN}$	(Note 4)	(Note 4)	High-Z
Standby	VCC ± 0.3 V	X	X	VCC ± 0.3 V	H	X	High-Z	High-Z	High-Z
Output Disable	L	H	H	H	L/H	X	High-Z	High-Z	High-Z
Reset	X	X	X	L	L/H	X	High-Z	High-Z	High-Z
Sector Protect (Note 2)	L	H	L	V$_{ID}$	L/H	Sector Address, A6=L, A1=H, A0=L	(Note 4)	X	X
Sector Unprotect (Note 2)	L	H	L	V$_{ID}$	L/H	Sector Address, A6=H, A1=H, A0=L	(Note 4)	X	X
Temporary Sector Unprotect	X	X	X	V$_{ID}$	L/H	A$_{IN}$	(Note 4)	(Note 4)	High-Z

Legend:
L = Logic Low = V$_{IL}$, H = Logic High = V$_{IH}$, V$_{ID}$ = 11.5V-12.5V, V$_{HH}$ = 11.5V-12.5V, X = Don't Care, D$_{IN}$ = Data In, D$_{OUT}$ = Data Out, A$_{IN}$ = Address In
Notes:

1. Addresses are A20:A0 in word mode ($\overline{\text{BYTE}}$=V$_{IH}$), A20: A$_{-1}$ in byte mode ($\overline{\text{BYTE}}$ =V$_{IL}$).

2. The sector protect and sector unprotect functions may also be implemented via programming equipment. See "Sector/Sector Block Protection and Unprotection".

3. If $\overline{\text{WP}}$/ACC=V$_{IL}$, the two outermost boot sectors remain protected. If $\overline{\text{WP}}$/ACC=V$_{IH}$, the two outermost boot sector protection depends on whether they were last protected or unprotected using the method described in "Sector/Sector Block Protection and Unprotection. If $\overline{\text{WP}}$/ACC = V$_{HH}$, all sectors are unprotected.

4. D$_{IN}$ or D$_{OUT}$ as required by command sequence, data polling, or sector protection algorithm.

Word/Byte Configuration

The $\overline{BYTE}$ pin determines whether the I/O pins I/O15-I/O0 operate in the byte or word configuration. If the $\overline{BYTE}$ pin is set at logic "1", the device is in word configuration, I/O15-I/O0 are active and controlled by $\overline{CE}$ and $\overline{OE}$.

If the $\overline{BYTE}$ pin is set at logic "0", the device is in byte configuration, and only I/O0-I/O7 are active and controlled by $\overline{CE}$ and $\overline{OE}$. I/O8-I/O14 are tri-stated, and I/O15 pin is used as an input for the LSB(A-1) address function.

Requirements for Reading Array Data

To read array data from the outputs, the system must drive the $\overline{CE}$ and $\overline{OE}$ pins to VIL. $\overline{CE}$ is the power control and selects the device. $\overline{OE}$ is the output control and gates array data to the output pins. $\overline{WE}$ should remain at VIH all the time during read operation. The $\overline{BYTE}$ pin determines whether the device outputs array data in words and bytes. The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device remains enabled for read access until the command register contents are altered.

See "Reading Array Data" for more information. Refer to the AC Read Operations table for timing specifications and to the Read Operations Timings diagram for the timing waveforms, Icc1 in the DC Characteristics table represents the active current specification for reading array data.

Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive $\overline{WE}$ and $\overline{CE}$ to VIL, and $\overline{OE}$ to VIH. For program operations, the $\overline{BYTE}$ pin determines whether the device accepts program data in bytes or words, Refer to "Word/Byte Configuration" for more information. The device features an Unlock Bypass mode to facilitate faster programming. Once the device enters the Unlock Bypass mode, only two write cycles are required to program a word or byte, instead of four. The "
Word / Byte Program Command Sequence" section has details on programming data to the device using both standard and Unlock Bypass command sequence. An erase operation can erase one sector, multiple sectors, or the entire device. The Sector Address Tables indicate the address range that each sector occupies. A "sector address" consists of the address inputs required to uniquely select a sector. See the "Command Definitions" section for details on erasing a sector or the entire chip, or suspending/resuming the erase operation.

After the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on I/O7 - I/O0. Standard read cycle timings apply in this mode. Refer to the "Autoselect Mode" and "Autoselect Command Sequence" sections for more information.

Icc2 in the DC Characteristics table represents the active current specification for the write mode. The "AC

Characteristics" section contains timing specification tables and timing diagrams for write operations.

Program and Erase Operation Status

During an erase or program operation, the system may check the status of the operation by reading the status bits on I/O7 - I/O0. Standard read cycle timings and Icc read specifications apply. Refer to "Write Operation Status" for more information, and to each AC Characteristics section for timing diagrams.

Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the $\overline{OE}$ input.

The device enters the CMOS standby mode when the $\overline{CE}$ & $\overline{RESET}$ pins are both held at VCC $\pm$ 0.3V. (Note that this is a more restricted voltage range than VIH.) If $\overline{CE}$ and $\overline{RESET}$ are held at VIH, but not within VCC $\pm$ 0.3V, the device will be in the standby mode, but the standby current will be greater. The device requires the standard access time (tCE) before it is ready to read data.
If the device is deselected during erasure or programming, the device draws active current until the operation is completed.
Icc3 and Icc4 in the DC Characteristics tables represent the standby current specification.

Automatic Sleep Mode

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for tACC +30ns. The automatic sleep mode is independent of the $\overline{CE}$, $\overline{WE}$ and $\overline{OE}$ control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system. Icc4 in the DC Characteristics table represents the automatic sleep mode current specification.

Output Disable Mode

When the $\overline{OE}$ input is at VIH, output from the device is disabled. The output pins are placed in the high impedance state.

$\overline{RESET}$: Hardware Reset Pin

The $\overline{RESET}$ pin provides a hardware method of resetting the device to reading array data. When the system drives the $\overline{RESET}$ pin low for at least a period of tRP, the device immediately terminates any operation in progress, tristates all data output pins, and ignores all read/write attempts for the duration of the $\overline{RESET}$ pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the $\overline{RESET}$ pulse. When $\overline{RESET}$ is held at VSS $\pm$ 0.3V, the device draws CMOS standby current (Icc4). If $\overline{RESET}$ is held at VIL but not within VSS $\pm$ 0.3V, the standby current will be greater.

The $\overline{\text{RESET}}$ pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash memory, enabling the system to read the boot-up firmware from the Flash memory.

If $\overline{\text{RESET}}$ is asserted during a program or erase operation, the RY/$\overline{\text{BY}}$ pin remains a "0" (busy) until the internal reset operation is complete, which requires a time tREADY (during Embedded Algorithms). The system can thus monitor

RY/$\overline{\text{BY}}$ to determine whether the reset operation is complete. If $\overline{\text{RESET}}$ is asserted when a program or erase operation is not executing (RY/$\overline{\text{BY}}$ pin is "1"), the reset operation is completed within a time of tREADY (not during Embedded Algorithms). The system can read data tRH after the $\overline{\text{RESET}}$ pin return to VIH.

Refer to the AC Characteristics tables for $\overline{\text{RESET}}$ parameters and diagram.

Table 2. A29L320A Top Boot Block Sector Address Table

Sector	A20-A12	Sector Size (Kbytes/ Kwords)	Address Range (in hexadecimal)	
			Byte Mode (x8)	Word Mode (x16)
SA0	000000XXX	64/32	000000 - 00FFFF	000000 - 007FFF
SA1	000001XXX	64/32	010000 - 01FFFF	008000 - 00FFFF
SA2	000010XXX	64/32	020000 - 02FFFF	010000 - 017FFF
SA3	000011XXX	64/32	030000 - 03FFFF	018000 - 01FFFF
SA4	000100XXX	64/32	040000 - 04FFFF	020000 - 027FFF
SA5	000101XXX	64/32	050000 - 05FFFF	028000 - 02FFFF
SA6	000110XXX	64/32	060000 - 06FFFF	030000 - 037FFF
SA7	000111XXX	64/32	070000 - 07FFFF	038000 - 03FFFF
SA8	001000XXX	64/32	080000 - 08FFFF	040000 - 047FFF
SA9	001001XXX	64/32	090000 - 09FFFF	048000 - 04FFFF
SA10	001010XXX	64/32	0A0000 - 0AFFFF	050000 - 057FFF
SA11	001011XXX	64/32	0B0000 - 0BFFFF	058000 - 05FFFF
SA12	001100XXX	64/32	0C0000 - 0CFFFF	060000 - 067FFF
SA13	001101XXX	64/32	0D0000 - 0DFFFF	068000 - 06FFFF
SA14	001110XXX	64/32	0E0000 - 0EFFFF	070000 - 077FFF
SA15	001111XXX	64/32	0F0000 - 0FFFFF	078000 - 07FFFF
SA16	010000XXX	64/32	100000 - 10FFFF	080000 - 087FFF
SA17	010001XXX	64/32	110000 - 11FFFF	088000 - 08FFFF
SA18	010010XXX	64/32	120000 - 12FFFF	090000 - 097FFF
SA19	010011XXX	64/32	130000 - 13FFFF	098000 - 09FFFF
SA20	010100XXX	64/32	140000 - 14FFFF	0A0000 - 0A7FFF
SA21	010101XXX	64/32	150000 - 15FFFF	0A8000 - 0AFFFF
SA22	010110XXX	64/32	160000 - 16FFFF	0B0000 - 0B7FFF
SA23	010111XXX	64/32	170000 - 17FFFF	0B8000 - 0BFFFF
SA24	011000XXX	64/32	180000 - 18FFFF	0C0000 - 0C7FFF
SA25	011001XXX	64/32	190000 - 19FFFF	0C8000 - 0CFFFF
SA26	011010XXX	64/32	1A0000 - 1AFFFF	0D0000 - 0D7FFF
SA27	011011XXX	64/32	1B0000 - 1BFFFF	0D8000 - 0DFFFF
SA28	011100XXX	64/32	1C0000 - 1CFFFF	0E0000 - 0E7FFF
SA29	011101XXX	64/32	1D0000 - 1DFFFF	0E8000 - 0EFFFF
SA30	011110XXX	64/32	1E0000 - 1EFFFF	0F0000 - 0F7FFF
SA31	011111XXX	64/32	1F0000 - 1FFFFF	0F8000 - 0FBFFF
SA32	100000XXX	64/32	200000 - 20FFFF	100000 - 107FFF
SA33	100001XXX	64/32	210000 - 21FFFF	108000 - 10FFFF
SA34	100010XXX	64/32	220000 - 22FFFF	110000 - 117FFF

Table 2. A29L320A Top Boot Block Sector Address Table

Sector	A20-A12	Sector Size (Kbytes/ Kwords)	Address Range (in hexadecimal)	
			Byte Mode (x8)	Word Mode (x16)
SA35	100011XXX	64/32	230000 - 23FFFF	118000 - 11FFFF
SA36	100100XXX	64/32	240000 - 24FFFF	120000 - 127FFF
SA37	100101XXX	64/32	250000 - 25FFFF	128000 - 12FFFF
SA38	100110XXX	64/32	260000 - 26FFFF	130000 - 137FFF
SA39	100111XXX	64/32	270000 - 27FFFF	138000 - 13FFFF
SA40	101000XXX	64/32	280000 - 28FFFF	140000 - 147FFF
SA41	101001XXX	64/32	290000 - 29FFFF	148000 - 14FFFF
SA42	101010XXX	64/32	2A0000 - 2AFFFF	150000 - 157FFF
SA43	101011XXX	64/32	2B0000 - 2BFFFF	158000 - 15FFFF
SA44	101100XXX	64/32	2C0000 - 2CFFFF	160000 - 167FFF
SA45	101101XXX	64/32	2D0000 - 2DFFFF	168000 - 16FFFF
SA46	101110XXX	64/32	2E0000 - 2EFFFF	170000 - 177FFF
SA47	101111XXX	64/32	2F0000 - 2FFFFF	178000 - 17FFFF
SA48	110000XXX	64/32	300000 - 30FFFF	180000 - 187FFF
SA49	110001XXX	64/32	310000 - 31FFFF	188000 - 18FFFF
SA50	110010XXX	64/32	320000 - 32FFFF	190000 - 197FFF
SA51	110011XXX	64/32	330000 - 33FFFF	198000 - 19FFFF
SA52	110100XXX	64/32	340000 - 34FFFF	1A0000 - 1A7FFF
SA53	110101XXX	64/32	350000 - 35FFFF	1A8000 - 1AFFFF
SA54	110110XXX	64/32	360000 - 36FFFF	1B0000 - 1B7FFF
SA55	110111XXX	64/32	370000 - 37FFFF	1B8000 - 1BFFFF
SA56	111000XXX	64/32	380000 - 38FFFF	1C0000 - 1C7FFF
SA57	111001XXX	64/32	390000 - 39FFFF	1C8000 - 1CFFFF
SA58	111010XXX	64/32	3A0000 - 3AFFFF	1D0000 - 1D7FFF
SA59	111011XXX	64/32	3B0000 - 3BFFFF	1D8000 - 1DFFFF
SA60	111100XXX	64/32	3C0000 - 3CFFFF	1E0000 - 1E7FFF
SA61	111101XXX	64/32	3D0000 - 3DFFFF	1E8000 - 1EFFFF
SA62	111110XXX	64/32	3E0000 - 3EFFFF	1F0000 - 1F7FFF
SA63	111111000	8/4	3F0000 - 3FFFFF	1F8000 - 1F8FFF
SA64	111111001	8/4	3F2000 - 3F3FFF	1F9000 - 1F9FFF
SA65	111111010	8/4	3F4000 - 3F5FFF	1FA000 - 1FAFFF
SA66	111111011	8/4	3F6000 - 3F7FFF	1FB000 - 1FBFFF
SA67	111111100	8/4	3F8000 - 3F9FFF	1FC000 - 1FCFFF
SA68	111111101	8/4	3FA000 - 3FBFFF	1FD000 - 1FDFFF
SA69	111111110	8/4	3FC000 - 3FDFFF	1FE000 - 1FEFFF
SA70	111111111	8/4	3FE000 - 3FFFFF	1FF000 - 1FFFFF

Note:
Address range is A20 : A$_{-1}$ in byte mode and A20 : A0 in word mode. See "Word/Byte Configuration" section.

Table 3. A29L320A Bottom Boot Block Sector Address Table

Sector	A20 -A12	Sector Size (Kbytes/ Kwords)	Address Range (in hexadecimal)	
			Byte Mode (x8)	Word Mode (x16)
SA0	000000000	8/4	000000 - 001FFF	000000 - 000FFF
SA1	000000001	8/4	002000 - 003FFF	001000 - 001FFF
SA2	000000010	8/4	004000 - 005FFF	002000 - 002FFF
SA3	000000011	8/4	006000 - 007FFF	003000 - 003FFF
SA4	000000100	8/4	008000 - 009FFF	004000 - 004FFF
SA5	000000101	8/4	00A000 - 00BFFF	005000 - 005FFF
SA6	000000110	8/4	00C000 - 00DFFF	006000 - 006FFF
SA7	000000111	8/4	00E000 - 00FFFF	007000 - 007FFF
SA8	000001XXX	64/32	010000 - 01FFFF	008000 - 00FFFF
SA9	000010XXX	64/32	020000 - 02FFFF	010000 - 017FFF
SA10	000011XXX	64/32	030000 - 03FFFF	018000 - 01FFFF
SA11	000100XXX	64/32	040000 - 04FFFF	020000 - 027FFF
SA12	000101XXX	64/32	050000 - 05FFFF	028000 - 02FFFF
SA13	000110XXX	64/32	060000 - 06FFFF	030000 - 037FFF
SA14	000111XXX	64/32	070000 - 07FFFF	038000 - 03FFFF
SA15	001000XXX	64/32	080000 - 08FFFF	040000 - 047FFF
SA16	001001XXX	64/32	090000 - 09FFFF	048000 - 04FFFF
SA17	001010XXX	64/32	0A0000 - 0AFFFF	050000 - 057FFF
SA18	001011XXX	64/32	0B0000 - 0BFFFF	058000 - 05FFFF
SA19	001100XXX	64/32	0C0000 - 0CFFFF	060000 - 067FFF
SA20	001101XXX	64/32	0D0000 - 0DFFFF	068000 - 06FFFF
SA21	001110XXX	64/32	0E0000 - 0EFFFF	070000 - 077FFF
SA22	001111XXX	64/32	0F0000 - 0FFFFF	078000 - 07FFFF
SA23	010000XXX	64/32	100000 - 10FFFF	080000 - 087FFF
SA24	010001XXX	64/32	110000 - 11FFFF	088000 - 08FFFF
SA25	010010XXX	64/32	120000 - 12FFFF	090000 - 097FFF
SA26	010011XXX	64/32	130000 - 13FFFF	098000 - 09FFFF
SA27	010100XXX	64/32	140000 - 14FFFF	0A0000 - 0A7FFF
SA28	010101XXX	64/32	140000 - 14FFFF	0A8000 - 0AFFFF
SA29	010110XXX	64/32	160000 - 16FFFF	0B0000 - 0B7FFF
SA30	010111XXX	64/32	170000 - 17FFFF	0B8000 - 0BFFFF
SA31	011000XXX	64/32	180000 - 18FFFF	0C0000 - 0C7FFF
SA32	011001XXX	64/32	190000 - 19FFFF	0C8000 - 0CFFFF
SA33	011010XXX	64/32	1A0000 - 1AFFFF	0D0000 - 0D7FFF
SA34	011011XXX	64/32	1B0000 - 1BFFFF	0D8000 - 0DFFFF

Table 3. A29L320A Bottom Boot Block Sector Address Table

Sector	A20 -A12	Sector Size (Kbytes/ Kwords)	Address Range (in hexadecimal)	
			Byte Mode (x8)	Word Mode (x16)
SA35	011100XXX	64/32	1C0000 - 1CFFFF	0E0000 - 0E7FFF
SA36	011101XXX	64/32	1D0000 - 1DFFFF	0E8000 - 0EFFFF
SA37	011110XXX	64/32	1E0000 - 1EFFFF	0F0000 - 0F7FFF
SA38	011111XXX	64/32	1F0000 - 1FFFFF	0F8000 - 0FFFFF
SA39	100000XXX	64/32	200000 - 20FFFF	100000 - 107FFF
SA40	100001XXX	64/32	210000 - 21FFFF	108000 - 10FFFF
SA41	100010XXX	64/32	220000 - 22FFFF	110000 - 117FFF
SA42	100011XXX	64/32	230000 - 23FFFF	118000 - 11FFFF
SA43	100100XXX	64/32	240000 - 24FFFF	120000 - 127FFF
SA44	100101XXX	64/32	250000 - 25FFFF	128000 - 12FFFF
SA45	100110XXX	64/32	260000 - 26FFFF	130000 - 137FFF
SA46	100111XXX	64/32	270000 - 27FFFF	138000 - 13FFFF
SA47	101000XXX	64/32	280000 - 28FFFF	140000 - 147FFF
SA48	101001XXX	64/32	290000 - 29FFFF	148000 - 14FFFF
SA49	101010XXX	64/32	2A0000 - 2AFFFF	150000 - 157FFF
SA50	101011XXX	64/32	2B0000 - 2BFFFF	158000 - 15FFFF
SA51	101100XXX	64/32	2C0000 - 2CFFFF	160000 - 167FFF
SA52	101101XXX	64/32	2D0000 - 2DFFFF	168000 - 16FFFF
SA53	101110XXX	64/32	2E0000 - 2EFFFF	170000 - 177FFF
SA54	101111XXX	64/32	2F0000 - 2FFFFF	178000 - 17FFFF
SA55	110000XXX	64/32	300000 - 30FFFF	180000 - 187FFF
SA56	110001XXX	64/32	310000 - 31FFFF	188000 - 18FFFF
SA57	110010XXX	64/32	320000 - 32FFFF	190000 - 197FFF
SA58	110011XXX	64/32	330000 - 33FFFF	198000 - 19FFFF
SA59	110100XXX	64/32	340000 - 34FFFF	1A0000 - 1A7FFF
SA60	110101XXX	64/32	350000 - 35FFFF	1A8000 - 1AFFFF
SA61	110110XXX	64/32	360000 - 36FFFF	1B0000 - 1B7FFF
SA62	110111XXX	64/32	370000 - 37FFFF	1B8000 - 1BFFFF
SA63	111000XXX	64/32	380000 - 38FFFF	1C0000 - 1C7FFF
SA64	111001XXX	64/32	390000 - 39FFFF	1C8000 - 1CFFFF
SA65	111010XXX	64/32	3A0000 - 3AFFFF	1D0000 - 1D7FFF
SA66	111011XXX	64/32	3B0000 - 3BFFFF	1D8000 - 1DFFFF
SA67	111100XXX	64/32	3C0000 - 3CFFFF	1E0000 - 1E7FFF
SA68	111101XXX	64/32	3D0000 - 3DFFFF	1E8000 - 1EFFFF
SA69	111110XXX	64/32	3E0000 - 3EFFFF	1F0000 - 1F7FFF
SA70	111111XXX	64/32	3F0000 - 3FFFFF	1F8000 - 1FFFFF

Note:
Address range is A20 : A$_{-1}$ in byte mode and A20 : A0 in word mode. See "Word/Byte Configuration" section.

Autoselect Mode

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on I/O$_7$ - I/O$_0$. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register. When using programming equipment, the autoselect mode requires V$_{ID}$ (11.5V to 12.5V) on address pin A9. Address pins A6, A1, and A0 must be as shown in Autoselect Codes (High Voltage Method) table. In addition, when verifying sector protection, the sector address must appear on the appropriate highest order address bits. Refer to the corresponding Sector Address Tables. The Command Definitions table shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on I/O$_7$ - I/O$_0$.To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in the Command Definitions table. This method does not require V$_{ID}$. See "Command Definitions" for details on using the autoselect mode.

Table 4. A29L320A Autoselect Codes (High Voltage Method)

Description	Mode	$\overline{CE}$	$\overline{OE}$	$\overline{WE}$	A20 to A12	A11 to A10	A9	A8 to A7	A6	A5 to A2	A1	A0	I/O$_8$ to I/O$_{15}$	I/O$_7$ to I/O$_0$
Manufacturer ID: AMIC		L	L	H	X	X	V$_{ID}$	X	L	X	L	L	X	37h
Device ID: A29L320A (Top Boot Block)	Word	L	L	H	X	X	V$_{ID}$	X	L	X	L	H	22h	F6h
	Byte												X	F6h
Device ID: A29L320A (Bottom Boot Block)	Word	L	L	H	X	X	V$_{ID}$	X	L	X	L	H	22h	F9h
	Byte												X	F9h
Continuation ID		L	L	H	X	X	V$_{ID}$	X	L	X	H	H	X	7Fh
Sector Protection Verification		L	L	H	SA	X	V$_{ID}$	X	L	X	H	L	X	01h (protected)
													X	00h (unprotected)

L=Logic Low= V$_{IL}$, H=Logic High=V$_{IH}$, SA=Sector Address, X=Don't Care.

Note: The autoselect codes may also be accessed in-system via command sequences.

Sector/Sector Block Protection and Unprotection

(Note: For the following discussion, the term "sector" applies to both sectors and sector blocks. A sector block consists of two or more adjacent sectors that are protected or unprotected at the same time (see Tables 5 and 6).

Table 5. Top Boot Sector/Sector Block Addresses for Protection/Unprotection

Sector / Sector Block	A20–A12	Sector / Sector Block Size
SA0	000000XXX	64 Kbytes
SA1-SA3	000001XXX 000010XXX 000011XXX	192 (3x64) Kbytes
SA4-SA7	0001XXXXX	256 (4x64) Kbytes
SA8-SA11	0010XXXXX	256 (4x64) Kbytes
SA12-SA15	0011XXXXX	256 (4x64) Kbytes
SA16-SA19	0100XXXXX	256 (4x64) Kbytes
SA20-SA23	0101XXXXX	256 (4x64) Kbytes
SA24-SA27	0110XXXXX	256 (4x64) Kbytes
SA28-SA31	0111XXXXX	256 (4x64) Kbytes
SA32-SA35	1000XXXXX	256 (4x64) Kbytes
SA36-SA39	1001XXXXX	256 (4x64) Kbytes
SA40-SA43	1010XXXXX	256 (4x64) Kbytes
SA44-SA47	1011XXXXX	256 (4x64) Kbytes
SA48-SA51	1100XXXXX	256 (4x64) Kbytes
SA52-SA55	1101XXXXX	256 (4x64) Kbytes
SA56-SA59	1110XXXXX	256 (4x64) Kbytes
SA60-SA62	111100XXX 111101XXX 111110XXX	192 (3x64) Kbytes
SA63	111111000	8 Kbytes
SA64	111111001	8 Kbytes
SA65	111111010	8 Kbytes
SA66	111111011	8 Kbytes
SA67	111111100	8 Kbytes
SA68	111111101	8 Kbytes
SA69	111111110	8 Kbytes
SA70	111111111	8 Kbytes

Table 6. Bottom Boot Sector/Sector Block Addresses for Protection/Unprotection

Sector / Sector Block	A20–A12	Sector / Sector Block Size
SA70	111111XXX	64 Kbytes
SA69- SA67	111110XXX 111101XXX 111100XXX	192 (3x64) Kbytes
SA66- SA63	1110XXXXX	256 (4x64) Kbytes
SA62- SA59	1101XXXXX	256 (4x64) Kbytes
SA58- SA55	1100XXXXX	256 (4x64) Kbytes
SA54- SA51	1011XXXXX	256 (4x64) Kbytes
SA50- SA47	1010XXXXX	256 (4x64) Kbytes
SA46-SA43	1001XXXXX	256 (4x64) Kbytes
SA42-SA39	1000XXXXX	256 (4x64) Kbytes
SA38-SA35	0111XXXXX	256 (4x64) Kbytes
SA34-SA31	0110XXXXX	256 (4x64) Kbytes
SA30-SA27	0101XXXXX	256 (4x64) Kbytes
SA26-SA23	0100XXXXX	256 (4x64) Kbytes
SA22-SA19	0011XXXXX	256 (4x64) Kbytes
SA18-SA15	0010XXXXX	256 (4x64) Kbytes
SA14-SA11	0001XXXXX	256 (4x64) Kbytes
SA10-SA8	000001XXX 000010XXX 000011XXX	192 (3x64) Kbytes
SA7	000000111	8 Kbytes
SA6	000000110	8 Kbytes
SA5	000000101	8 Kbytes
SA4	000000100	8 Kbytes
SA3	000000011	8 Kbytes
SA2	000000010	8 Kbytes
SA1	000000001	8 Kbytes
SA0	000000000	8 Kbytes

Sector Protection/Unprotection

The hardware sector protection feature disables both program and erase operations in any sector. The hardware sector unprotection feature re-enables both program and erase operations in previously protected sectors.

It is possible to determine whether a sector is protected or unprotected. See "Autoselect Mode" for details.

Sector protection / unprotection can be implemented via two methods. The primary method requires VID on the $\overline{RESET}$ pin only, and can be implemented either in-system or via programming equipment. Figure 2 shows the algorithm and the Sector Protect / Unprotect Timing Diagram illustrates the timing waveforms for this feature. This method uses standard microprocessor bus cycle timing. For sector unprotect, all unprotected sectors must first be protected prior to the first sector unprotect write cycle. The alternate method for protection and unprotection is by software sector block protect/unprotect command. See Figure 2 for Command Flow.

The device is shipped with all sectors unprotected.

It is possible to determine whether a sector is protected or unprotected. See "Autoselect Mode" for details.

Hardware Data Protection

The requirement of command unlocking sequence for programming or erasing provides data protection against inadvertent writes (refer to the Command Definitions table). In addition, the following hardware data protection measures prevent accidental erasure or programming, which might otherwise be caused by spurious system level signals during Vcc power-up transitions, or from system noise. The device is powered up to read array data to avoid accidentally writing data to the array.

Write Pulse "Glitch" Protection

Noise pulses of less than 5ns (typical) on $\overline{OE}$, $\overline{CE}$ or $\overline{WE}$ do not initiate a write cycle.

Logical Inhibit

Write cycles are inhibited by holding any one of $\overline{OE}$ =VIL, $\overline{CE}$ = VIH or $\overline{WE}$ = VIH. To initiate a write cycle, $\overline{CE}$ and $\overline{WE}$ must be a logical zero while $\overline{OE}$ is a logical one.

Power-Up Write Inhibit

If $\overline{WE}$ = $\overline{CE}$ = VIL and $\overline{OE}$ = VIH during power up, the device does not accept commands on the rising edge of $\overline{WE}$. The internal state machine is automatically reset to reading array data on the initial power-up.

Temporary Sector Unprotect

This feature allows temporary unprotection of previous protected sectors to change data in-system. The Sector Unprotect mode is activated by setting the $\overline{RESET}$ pin to VID. During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once VID is removed from the $\overline{RESET}$ pin, all the previously protected sectors are protected again. Figure 1 shows the algorithm, and the Temporary Sector Unprotect diagram shows the timing waveforms, for this feature.
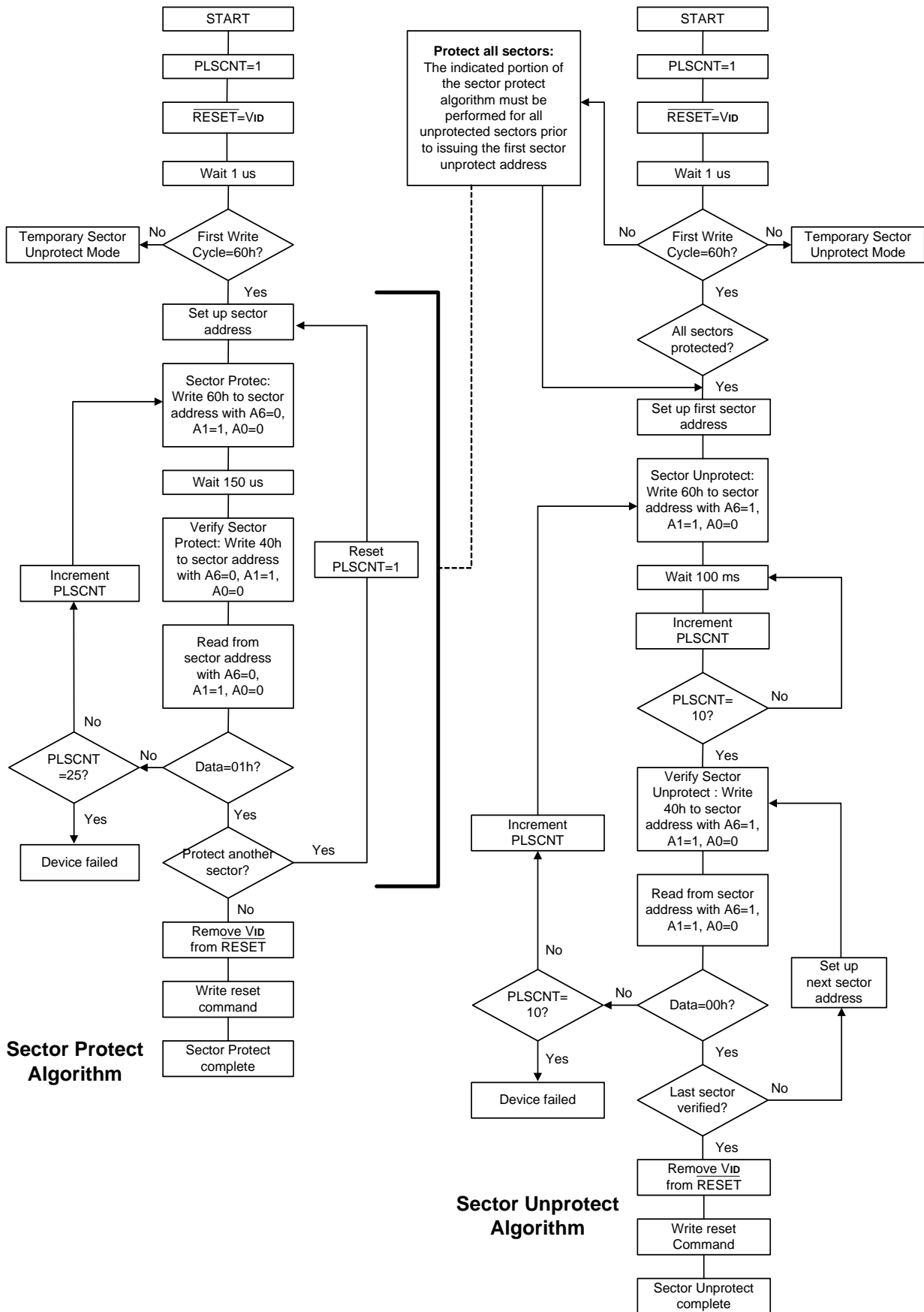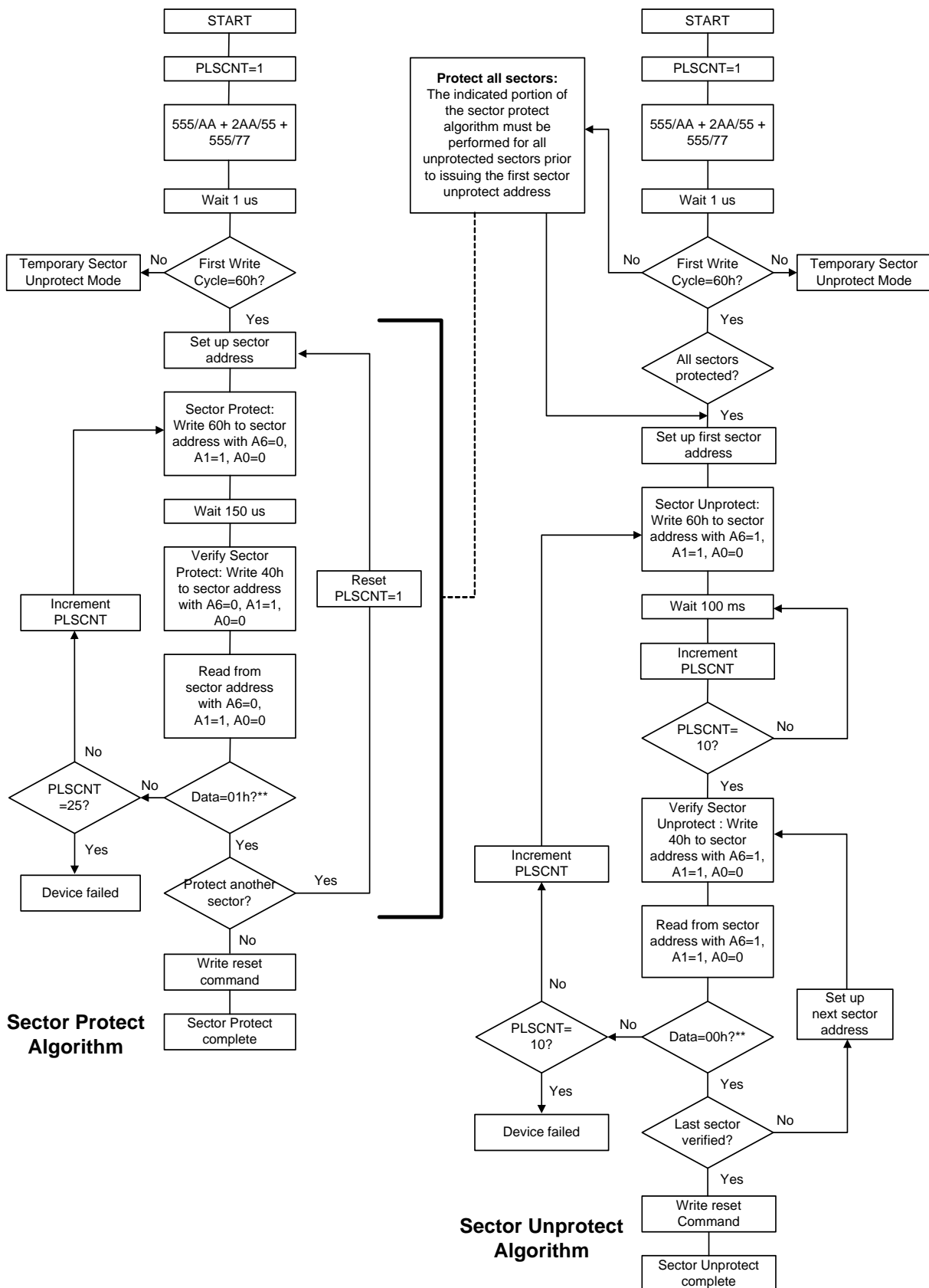
```
┌──────────────┐
│    START     │
└──────┬───────┘
       ▼
┌──────────────┐
│  RESET = VID  │
│   (Note 1)   │
└──────┬───────┘
       ▼
┌──────────────┐
│ Perform Erase or │
│ Program Operations │
└──────┬───────┘
       ▼
┌──────────────┐
│  RESET = VIH  │
└──────┬───────┘
       ▼
┌──────────────┐
│ Temporary Sector │
│   Unprotect    │
│ Completed (Note 2) │
└──────────────┘
```

Notes:
1. All protected sectors unprotected (If WP/ACC=VIL, outermost boot sectors will remain protected).
2. All previously protected sectors are protected once again.

Figure 1-1. Temporary Sector Unprotect Operation by RESET Mode

```
┌──────────────┐
│    START     │
└──────┬───────┘
       ▼
┌──────────────┐
│ 555/AA + 2AA/55 + 555/77 │
│   (Note 1)   │
└──────┬───────┘
       ▼
┌──────────────┐
│ Perform Erase or │
│ Program Operations │
└──────┬───────┘
       ▼
┌──────────────┐
│   XXX/F0     │
│ (Reset Command) │
└──────┬───────┘
       ▼
┌──────────────┐
│ Soft-ware Temporary │
│ Sector Unprotect │
│   Completed    │
│   (Note 2)     │
└──────────────┘
```

Notes:
1. All protected sectors unprotected (If WP/ACC=VIL, outermost boot sectors will remain protected).
2. All previously protected sectors are protected once again.

Figure 1-2. Temporary Sector Unprotect Operation by Software Mode

Sector Protect Algorithm (left)

START

PLSCNT=1

$\overline{RESET}$=V$_{ID}$

Wait 1 us

First Write Cycle=60h? — No → Temporary Sector Unprotect Mode

Yes

Set up sector address

Sector Protec: Write 60h to sector address with A6=0, A1=1, A0=0

Wait 150 us

Verify Sector Protect: Write 40h to sector address with A6=0, A1=1, A0=0

Read from sector address with A6=0, A1=1, A0=0

Data=01h? — No → PLSCNT =25? — No → Increment PLSCNT

PLSCNT =25? — Yes → Device failed

Data=01h? — Yes → Protect another sector? — Yes → Set up sector address (Reset PLSCNT=1)

Protect another sector? — No

Remove V$_{ID}$ from $\overline{RESET}$

Write reset command

Sector Protect complete

Sector Protect Algorithm

Protect all sectors: The indicated portion of the sector protect algorithm must be performed for all unprotected sectors prior to issuing the first sector unprotect address

Sector Unprotect Algorithm (right)

START

PLSCNT=1

$\overline{RESET}$=V$_{ID}$

Wait 1 us

First Write Cycle=60h? — No / No → Temporary Sector Unprotect Mode

Yes

All sectors protected? — Yes

Set up first sector address

Sector Unprotect: Write 60h to sector address with A6=1, A1=1, A0=0

Wait 100 ms

Increment PLSCNT

PLSCNT= 10? — No → Wait 100 ms

Yes

Verify Sector Unprotect : Write 40h to sector address with A6=1, A1=1, A0=0

Read from sector address with A6=1, A1=1, A0=0

Data=00h? — No → PLSCNT= 10? — No → Increment PLSCNT

PLSCNT= 10? — Yes → Device failed

Data=00h? — Yes → Last sector verified? — No → Set up next sector address

Last sector verified? — Yes

Remove V$_{ID}$ from $\overline{RESET}$

Write reset Command

Sector Unprotect complete

Sector Unprotect Algorithm

Figure 2-1. In-System Sector Protect/Unprotect Algorithms

START

PLSCNT=1

555/AA + 2AA/55 + 555/77

Wait 1 us

Protect all sectors:
The indicated portion of the sector protect algorithm must be performed for all unprotected sectors prior to issuing the first sector unprotect address

First Write Cycle=60h? — No → Temporary Sector Unprotect Mode

Yes

Set up sector address

Sector Protect: Write 60h to sector address with A6=0, A1=1, A0=0

Wait 150 us

Verify Sector Protect: Write 40h to sector address with A6=0, A1=1, A0=0

Read from sector address with A6=0, A1=1, A0=0

Increment PLSCNT

Reset PLSCNT=1

PLSCNT =25? — No

Data=01h?** — No

Yes

Device failed

Protect another sector? — Yes

No

Write reset command

Sector Protect complete

Sector Protect Algorithm

START

PLSCNT=1

555/AA + 2AA/55 + 555/77

Wait 1 us

No ← First Write Cycle=60h? → No → Temporary Sector Unprotect Mode

Yes

All sectors protected?

Yes

Set up first sector address

Sector Unprotect: Write 60h to sector address with A6=1, A1=1, A0=0

Wait 100 ms

Increment PLSCNT

PLSCNT= 10? — No

Yes

Verify Sector Unprotect : Write 40h to sector address with A6=1, A1=1, A0=0

Read from sector address with A6=1, A1=1, A0=0

Increment PLSCNT

PLSCNT= 10? — No

Data=00h?** — Yes

Set up next sector address

No

Yes

Device failed

Last sector verified? — No

Yes

Write reset Command

Sector Unprotect complete

Sector Unprotect Algorithm

Note: The term "sector" in the figure applies to both sectors and sector blocks
  * No other command is allowed during this process
  ** Access time is 200ns-300ns

Figure 2-2. Software Sector/Sector Block Protection and Unprotection Algorithms

Common Flash Memory Interface (CFI)

The Common Flash Interface (CFI) specification outlines device and host system software interrogation handshake, which allows specific vendor-specified software algorithms to be used for entire families of devices. Software support can then be device-independent, JEDEC ID-independent, and forward- and backward-compatible for the specified flash device families. Flash vendors can standardize their existing interface for long-term compatibility.

This device enters the CFI Query mode when the system writes the CFI Query command, 98h, to address 55h in word mode (or address AAh in byte mode), any time the device is ready to read array data. The system can read CFI information at the addresses given in Table 5-8. In word mode, the upper address bits (A7-MSB) must be all zeros. To terminate reading CFI data, the system must write the reset command.

The system can also write the CFI query command when the device is in the autoselect mode. The device enters the CFI query mode, and the system can read CFI data at the addresses given in Table 5-8. The system must write the reset command to return the device to the autoselect mode.

Table 7. CFI Query Identification String

Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
10h	20h	0051h	
11h	22h	0052h	Query Unique ASCII string "QRY"
12h	24h	0059h	
13h	26h	0002h	Primary OEM Command Set
14h	28h	0000h	
15h	2Ah	0040h	Address for Primary Extended Table
16h	2Ch	0000h	
17h	2Eh	0000h	Alternate OEM Command Set (00h = none exists)
18h	30h	0000h	
19h	32h	0000h	Address for Alternate OEM Extended Table (00h = none exists)
1Ah	34h	0000h	

Table 8. System Interface String

Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
1Bh	36h	0027h	VCC Min. (write/erase) I/O_7- I/O_4 : volt, I/O_3- I/O_0: 100 millivolt
1Ch	38h	0036h	VCC Max. (write/erase) I/O_7- I/O_4: volt, I/O_3- I/O_0: 100 millivolt
1Dh	3Ah	0000h	Vpp Min. voltage (00h = no Vpp pin present)
1Eh	3Ch	0000h	Vpp Max. voltage (00h = no Vpp pin present)
1Fh	3Eh	0004h	Typical timeout per single byte/word write 2^N μs
20h	40h	0000h	Typical timeout for Min. size buffer write 2^N μs (00h = not supported)
21h	42h	000Ah	Typical timeout per individual block erase 2^N ms
22h	44h	0000h	Typical timeout for full chip erase 2^N ms (00h = not supported)
23h	46h	0005h	Max. timeout for byte/word write 2^N times typical
24h	48h	0000h	Max. timeout for buffer write 2^N times typical
25h	4Ah	0004h	Max. timeout per individual block erase 2^N times typical
26h	4Ch	0000h	Max. timeout for full chip erase 2^N times typical (00h = not supported)

Table 9. Device Geometry Definition

Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
27h	4Eh	0016h	Device Size = 2^N byte
28h	50h	0002h	Flash Device Interface description
29h	52h	0000h	
2Ah	54h	0000h	Max. number of byte in multi-byte write = 2^N
2Bh	56h	0000h	(00h = not supported)
2Ch	58h	0002h	Number of Erase Block Regions within device
2Dh	5Ah	0007h	
2Eh	5Ch	0000h	Erase Block Region 1 Information
2Fh	5Eh	0020h	(refer to the CFI specification)
30h	60h	0000h	
31h	62h	003Eh	
32h	64h	0000h	Erase Block Region 2 Information
33h	66h	0000h	
34h	68h	0001h	
35h	6Ah	0000h	
36h	6Ch	0000h	Erase Block Region 3 Information
37h	6Eh	0000h	
38h	70h	0000h	
39h	72h	0000h	
3Ah	74h	0000h	Erase Block Region 4 Information
3BH	76h	0000h	
3Ch	78h	0000h	

Table 10. Primary Vendor-Specific Extended Query

Addresses (Word Mode)	Addresses (Byte Mode)	Data	Description
40h	80h	0050h	
41h	82h	0052h	Query-unique ASCII string "PRI"
42h	84h	0049h	
43h	86h	0031h	Major version number, ASCII
44h	88h	0031h	Minor version number, ASCII
45h	8Ah	0000h	Address Sensitive Unlock 0 = Required, 1 = Not Required
46h	8Ch	0002h	Erase Suspend 0 = Not Supported, 1 = To Read Only, 2 = To Read & Write
47h	8Eh	0004h	Sector Protect 0 = Not Supported, X = Number of sectors in per group
48h	90h	0001h	Sector Temporary Unprotect 00 = Not Supported, 01 = Supported
49h	92h	0004h	Sector Protect/Unprotect scheme 01 = 29F040 mode, 02 = 29F016 mode, 03 = 29F400 mode, 04 = 29L160 mode
4Ah	94h	0000h	Simultaneous Operation 00 = Not Supported, 01 = Supported
4Bh	96h	0000h	Burst Mode Type 00 = Not Supported, 01 = Supported
4Ch	98h	0000h	Page Mode Type 00 = Not Supported, 01 = 4 Word Page, 02 = 8 Word Page
4Dh	9Ah	00B5h	ACC (Acceleration) Supply Minimum 00 = Not Supported, D7-D4: Volt, D3-D0: 100mV
4Eh	9Ch	00C5h	ACC (Acceleration) Supply Maximum 00 = Not Supported, D7-D4: Volt, D3-D0: 100mV
4Fh	9Eh	000Xh	Top/Bottom Boot Sector Flag 02 = Bottom Boot Device, 03h = Top Boot Device

START

↓

Write Program Command Sequence

↓

Data Poll from System

↓

Verify Data ? — No

↓ Yes

Last Address ? — No → Increment Address

↓ Yes

Programming Completed

Embedded Program algorithm in progress

Note : See the appropriate Command Definitions table for program command sequence.

Figure 3. Program Operation

Unlock Bypass Command Sequence

The unlock bypass feature allows the system to program bytes or words to the device faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock bypass mode. A two-cycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 9 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the two-cycle unlock bypass reset command sequence. The first cycle must contain the data 90h; the second cycle the data

00h. Addresses are don't care for both cycle. The device returns to reading array data.

Figure 3 illustrates the algorithm for the program operation. See the Erase/Program Operations in "AC Characteristics" for parameters, and to Program Operation Timings for timing diagrams.

Chip Erase Command Sequence

Chip erase is a six-bus-cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. The Command Definitions table shows the address and data requirements for the chip erase command sequence.

Any commands written to the chip during the Embedded Erase algorithm are ignored. The system can determine the status of the erase operation by using I/O_7, I/O_6, or I/O_2. See "Write Operation Status" for information on these status bits. When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched.

Figure 4 illustrates the algorithm for the erase operation. See the Erase/Program Operations tables in "AC Characteristics" for parameters, and to the Chip/Sector Erase Operation Timings for timing waveforms.

Sector Erase Command Sequence

Sector erase is a six-bus-cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the address of the sector to be erased, and the sector erase command. The Command Definitions table shows the address and data requirements for the sector erase command sequence.

The device does not require the system to preprogram the memory prior to erase. The Embedded Erase algorithm automatically programs and verifies the sector for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

After the command sequence is written, a sector erase time-out of 50μs begins. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50μs, otherwise the last address and command might not be accepted, and erasure may begin. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be re-enabled after the last Sector Erase command is written. If the time between additional sector erase commands can be assumed to be less than 50μs, the system need not monitor I/O_3. Any command other than Sector Erase or Erase Suspend during the time-out period resets the device to reading array data. The system must rewrite the command sequence and any additional sector addresses and commands.

The system can monitor I/O$_3$ to determine if the sector erase timer has timed out. (See the " I/O$_3$: Sector Erase Timer" section.) The time-out begins from the rising edge of the final $\overline{WE}$ pulse in the command sequence.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched. The system can determine the status of the erase operation by using I/O$_7$, I/O$_6$, or I/O$_2$. Refer to "Write Operation Status" for information on these status bits.

4 illustrates the algorithm for the erase operation. Refer to the Erase/Program Operations tables in the "AC Characteristics" section for parameters, and to the Sector Erase Operations Timing diagram for timing waveforms.

Erase Suspend/Erase Resume Commands

The Erase Suspend command allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the 50μs time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm. Writing the Erase Suspend command during the Sector Erase time-out immediately terminates the time-out period and suspends the erase operation. Addresses are "don't cares" when writing the Erase Suspend command.

When the Erase Suspend command is written during a sector erase operation, the device requires a maximum of 20μs to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the system can read array data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Normal read and write timings and command definitions apply. Reading at any address within erase-suspended sectors produces status data on I/O$_7$ - I/O$_0$. The system can use I/O$_7$, or I/O$_6$ and I/O$_2$ together, to determine if a sector is actively erasing or is erase-suspended. See "Write Operation Status" for information on these status bits.

After an erase-suspended program operation is complete, the system can once again read array data within non-suspended sectors. The system can determine the status of the program operation using the I/O$_7$ or I/O$_6$ status bits, just as in the standard program operation. See "Write Operation Status" for more information.

The system may also write the autoselect command sequence when the device is in the Erase Suspend mode. The device allows reading autoselect codes even at addresses within erasing sectors, since the codes are not stored in the memory array. When the device exits the autoselect mode, the device reverts to the Erase Suspend mode, and is ready for another valid operation. See "Autoselect Command Sequence" for more information.

The system must write the Erase Resume command (address bits are "don't care") to exit the erase suspend mode and continue the sector erase operation. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the device has resumed erasing.
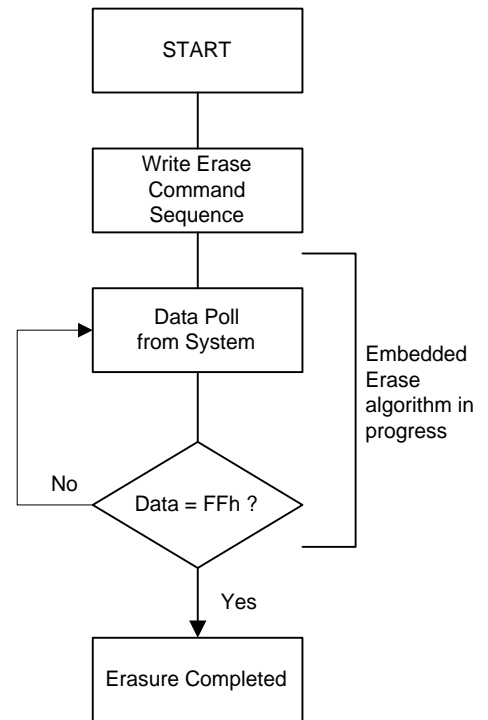
Note :
1. See the appropriate Command Definitions table for erase command sequences.
2. See "I/O$_3$: Sector Erase Timer" for more information.

Figure 4. Erase Operation

Table 11. A29L320A Command Definitions

Command Sequence (Note 1)			Cycles	First Addr	First Data	Second Addr	Second Data	Third Addr	Third Data	Fourth Addr	Fourth Data	Fifth Addr	Fifth Data	Sixth Addr	Sixth Data
Read (Note 6)			1	RA	RD										
Reset (Note 7)			1	XXX	F0										
Autoselect (Note 8)	Manufacturer ID	Word	4	555	AA	2AA	55	555	90	X00	37				
		Byte		AAA		555		AAA							
	Device ID, Top Boot Block	Word	4	555	AA	2AA	55	555	90	X01	22F6				
		Byte		AAA		555		AAA		X02	F6				
	Device ID, Bottom Boot Block	Word	4	555	AA	2AA	55	555	90	X01	22F9				
		Byte		AAA		555		AAA		X02	F9				
	Continuation ID	Word	4	555	AA	2AA	55	555	90	X03	7F				
		Byte		AAA		555		AAA		X06					
	Sector Protect Verify (Note 9)	Word	4	555	AA	2AA	55	555	90	(SA) X02	XX00 / XX01				
		Byte		AAA		555		AAA		(SA) X04	00 / 01				
CFI Query (Note 10)		Word	1	55	98										
		Byte		AA											
Command Temporary Sector Unprotect (Note9)		Word	3	555	AA	2AA	55	555	77						
		Byte		AAA		555		AAA							
Program		Byte	4	555	AA	2AA	55	555	A0	PA	PD				
		Byte		AAA		555		AAA							
Unlock Bypass		Word	3	555	AA	2AA	55	555	20						
		Byte		AAA		555		AAA							
Unlock Bypass Program (Note 11)			2	XXX	A0	PA	PD								
Unlock Bypass Reset (Note 12)			2	XXX	90	XXX	00								
Chip Erase		Word	6	555	AA	2AA	55	555	80	555	AA	2AA	55	555	10
		Byte		AAA		555		AAA		AAA		555		AAA	
Sector Erase		Word	6	555	AA	2AA	55	555	80	555	AA	2AA	55	SA	30
		Byte		AAA		555		AAA		AAA		555			
Erase Suspend (Note 13)			1	XXX	B0										
Erase Resume (Note 14)			1	XXX	30										

Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the $\overline{WE}$ or $\overline{CE}$ pulse, whichever happens later.

PD = Data to be programmed at location PA. Data latches on the rising edge of $\overline{WE}$ or $\overline{CE}$ pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A20- A12 select a unique sector.

Note:
1. See Table 1 for description of bus operations.
2. All values are in hexadecimal.
3. Except when reading array or autoselect data, all bus cycles are write operation.
4. Address bits A20 - A11 are don't cares for unlock and command cycles, unless SA or PA required.
5. No unlock or command cycles required when reading array data.
6. The Reset command is required to return to reading array data when device is in the autoselect mode, or if I/O$_5$ goes high (while the device is providing status data).
7. The fourth cycle of the autoselect command sequence is a read cycle.
8. The data is 00h for an unprotected sector and 01h for a protected sector. See "Autoselect Command Sequence" for more information.
9. Once a reset command is applied, software temporary unprotect is exit to return to read array data. But under erase suspend condition, this command is still effective even a reset command has been applied. The reset command which can deactivate the software temporary unprotect command is useful only after the erase command is complete.
10. Command is valid when device is ready to read array data or when device is in autoselect mode.
11. The Unlock Bypass command is required prior to the Unlock Bypass Program command.
12. The Unlock Bypass Reset command is required to return to reading array data when the device is in the unlock bypass mode.
13. The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode.
14. The Erase Resume command is valid only during the Erase Suspend mode.

Write Operation Status

Several bits, I/O$_2$, I/O$_3$, I/O$_5$, I/O$_6$, I/O$_7$, RY/$\overline{BY}$ are provided in the A29L320A to determine the status of a write operation. Table 10 and the following subsections describe the functions of these status bits. I/O$_7$, I/O$_6$ and RY/$\overline{BY}$ each offer a method for determining whether a program or erase operation is complete or in progress. These three bits are discussed first.

I/O$_7$: $\overline{Data}$ Polling

The $\overline{Data}$ Polling bit, I/O$_7$, indicates to the host system whether an Embedded Algorithm is in progress or completed, or whether the device is in Erase Suspend. $\overline{Data}$ Polling is valid after the rising edge of the final $\overline{WE}$ pulse in the program or erase command sequence.

During the Embedded Program algorithm, the device outputs on I/O$_7$ the complement of the datum programmed to I/O$_7$. This I/O$_7$ status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to I/O$_7$. The system must provide the program address to read valid status information on I/O$_7$. If a program address falls within a protected sector, $\overline{Data}$ Polling on I/O$_7$ is active for approximately 2μs, then the device returns to reading array data.

During the Embedded Erase algorithm, $\overline{Data}$ Polling produces a "0" on I/O$_7$. When the Embedded Erase algorithm is complete, or if the device enters the Erase Suspend mode, $\overline{Data}$ Polling produces a "1" on I/O$_7$. This is analogous to the complement/true datum output described for the Embedded Program algorithm: the erase function changes all the bits in a sector to "1"; prior to this, the device outputs the "complement," or "0." The system must provide an address within any of the sectors selected for erasure to read valid status information on I/O$_7$.

After an erase command sequence is written, if all sectors selected for erasing are protected, $\overline{Data}$ Polling on I/O$_7$ is active for approximately 100μs, then the device returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. When the system detects I/O$_7$ has changed from the complement to true data, it can read valid data at I/O$_7$ - I/O$_0$ on the following read cycles. This is because I/O$_7$ may change asynchronously with I/O$_0$ - I/O$_6$ while Output Enable ($\overline{OE}$) is asserted low. The $\overline{Data}$ Polling Timings (During Embedded Algorithms) figure in the "AC Characteristics" section illustrates this. Table 10 shows the outputs for $\overline{Data}$ Polling on I/O$_7$. Figure 5 shows the $\overline{Data}$ Polling algorithm.
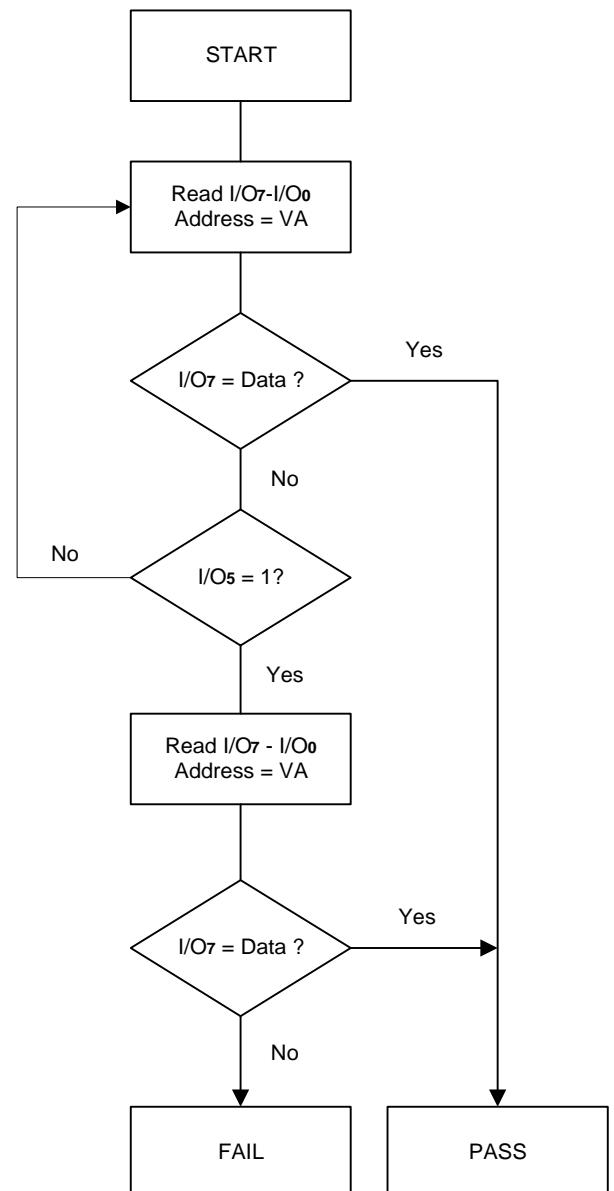
Note :
1. VA = Valid address for programming. During a sector erase operation, a valid address is an address within any sector selected for erasure. During chip erase, a valid address is any non-protected sector address.
2. I/O$_7$ should be rechecked even if I/O$_5$ = "1" because I/O$_7$ may change simultaneously with I/O$_5$.

Figure 5. $\overline{Data}$ Polling Algorithm

RY/$\overline{BY}$: Read/$\overline{Busy}$

The RY/$\overline{BY}$ is a dedicated, open-drain output pin that indicates whether an Embedded algorithm is in progress or complete. The RY/$\overline{BY}$ status is valid after the rising edge of the final $\overline{WE}$ pulse in the command sequence. Since RY/$\overline{BY}$ is an open-drain output, several RY/$\overline{BY}$ pins can be tied together in parallel with a pull-up resistor to VCC.

If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is ready to read array data (including during the Erase Suspend mode), or is in the standby mode.

Table 10 shows the outputs for RY/$\overline{BY}$. Refer to "$\overline{RESET}$ Timings", "Timing Waveforms for Program Operation" and "Timing Waveforms for Chip/Sector Erase Operation" for more information.

I/O$_6$: Toggle Bit I

Toggle Bit I on I/O$_6$ indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge of the final $\overline{WE}$ pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause I/O$_6$ to toggle. (The system may use either $\overline{OE}$ or $\overline{CE}$ to control the read cycles.) When the operation is complete, I/O$_6$ stops toggling.

After an erase command sequence is written, if all sectors selected for erasing are protected, I/O$_6$ toggles for approximately 100μs, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use I/O$_6$ and I/O$_2$ together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), I/O$_6$ toggles. When the device enters the Erase Suspend mode, I/O$_6$ stops toggling. However, the system must also use I/O$_2$ to determine which sectors are erasing or erase-suspended. Alternatively, the system can use I/O$_7$ (see the subsection on " I/O$_7$: Data Polling").

If a program address falls within a protected sector, I/O$_6$ toggles for approximately 2μs after the program command sequence is written, then returns to reading array data.

I/O$_6$ also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

The Write Operation Status table shows the outputs for Toggle Bit I on I/O$_6$. Refer to Figure 6 for the toggle bit algorithm, and to the Toggle Bit Timings figure in the "AC Characteristics" section for the timing diagram. The I/O$_2$ vs. I/O$_6$ figure shows the differences between I/O$_2$ and I/O$_6$ in graphical form. See also the subsection on " I/O$_2$: Toggle Bit II".

I/O$_2$: Toggle Bit II

The "Toggle Bit II" on I/O$_2$, when used with I/O$_6$, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final $\overline{WE}$ pulse in the command sequence. I/O$_2$ toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either $\overline{OE}$ or $\overline{CE}$ to control the read cycles.) But I/O$_2$ cannot distinguish whether the sector is actively erasing or is erase-suspended. I/O$_6$, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 10 to compare outputs for I/O$_2$ and I/O$_6$.

Figure 6 shows the toggle bit algorithm in flowchart form, and the section " I/O$_2$: Toggle Bit II" explains the algorithm. See also the " I/O$_6$: Toggle Bit I" subsection. Refer to the Toggle Bit Timings figure for the toggle bit timing diagram. The I/O$_2$ vs. I/O$_6$ figure shows the differences between I/O$_2$ and I/O$_6$ in graphical form.

Reading Toggle Bits I/O$_6$, I/O$_2$

Refer to Figure 6 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read I/O$_7$ - I/O$_0$ at least twice in a row to determine whether a toggle bit is toggling. Typically, a system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on I/O$_7$ - I/O$_0$ on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of I/O$_5$ is high (see the section on I/O$_5$). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as I/O$_5$ went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data. The remaining scenario is that the system initially determines that the toggle bit is toggling and I/O$_5$ has not gone high. The system may continue to monitor the toggle bit and I/O$_5$ through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Figure 6).

I/O$_5$: Exceeded Timing Limits

I/O$_5$ indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions I/O$_5$ produces a "1." This is a failure condition that indicates the program or erase cycle was not successfully completed.
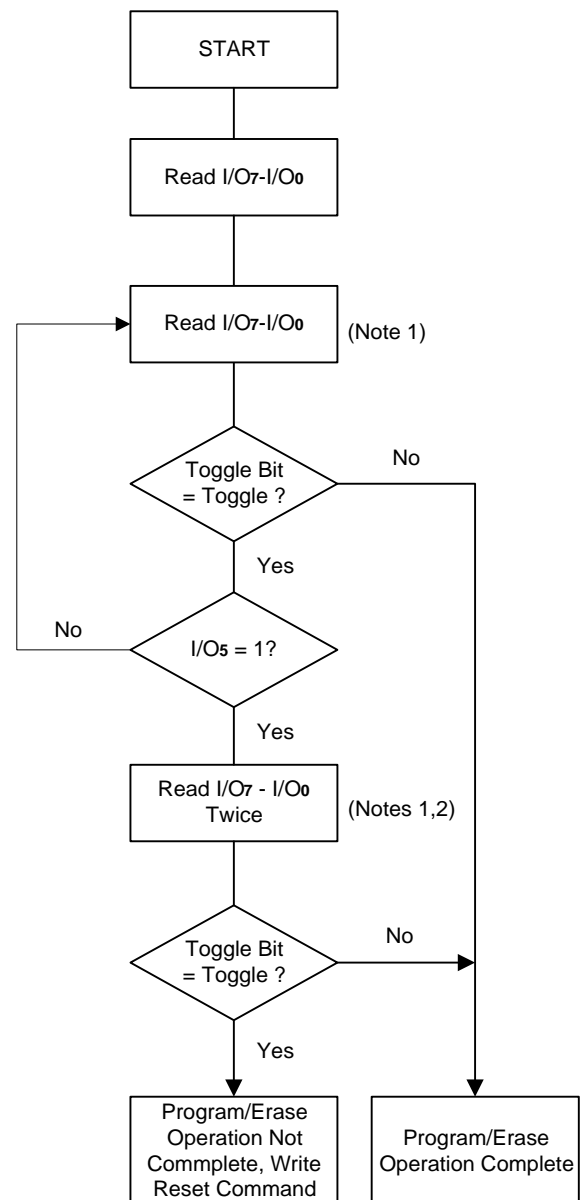
The I/O$_5$ failure condition may appear if the system tries to program a "1 "to a location that is previously programmed to "0." Only an erase operation can change a "0" back to a "1." Under this condition, the device halts the operation, and when the operation has exceeded the timing limits, I/O$_5$ produces a "1."

Under both these conditions, the system must issue the reset command to return the device to reading array data.

I/O$_3$: Sector Erase Timer

After writing a sector erase command sequence, the system may read I/O$_3$ to determine whether or not an erase operation has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out is complete, I/O$_3$ switches from "0" to "1." The system may ignore I/O$_3$ if the system can guarantee that the time between additional sector erase commands will always be less than 50μs. See also the "Sector Erase Command Sequence" section.

After the sector erase command sequence is written, the system should read the status on I/O$_7$ ($\overline{\text{Data}}$ Polling) or I/O$_6$ (Toggle Bit 1) to ensure the device has accepted the command sequence, and then read I/O$_3$. If I/O$_3$ is "1", the internally controlled erase cycle has begun; all further commands (other than Erase Suspend) are ignored until the erase operation is complete. If I/O$_3$ is "0", the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of I/O$_3$ prior to and following each subsequent sector erase command. If I/O$_3$ is high on the second status check, the last command might not have been accepted. Table 10 shows the outputs for I/O$_3$.

START

↓

Read I/O$_7$-I/O$_0$

↓

Read I/O$_7$-I/O$_0$ (Note 1)

↓

Toggle Bit = Toggle ? — No →

Yes ↓

I/O$_5$ = 1? — No →

Yes ↓

Read I/O$_7$ - I/O$_0$ Twice (Notes 1,2)

↓

Toggle Bit = Toggle ? — No →

Yes ↓

Program/Erase Operation Not Commplete, Write Reset Command

Program/Erase Operation Complete

Notes :
1. Read toggle bit twice to determine whether or not it is toggling. See text.
2. Recheck toggle bit because it may stop toggling as I/O$_5$ changes to "1". See text.

Figure 6. Toggle Bit Algorithm

Table 12. Write Operation Status

Operation		I/O7 (Note 1)	I/O6	I/O5 (Note 2)	I/O3	I/O2 (Note 1)	RY/$\overline{BY}$
Standard Mode	Embedded Program Algorithm	$\overline{I/O_7}$	Toggle	0	N/A	No toggle	0
	Embedded Erase Algorithm	0	Toggle	0	1	Toggle	0
Erase Suspend Mode	Reading within Erase Suspended Sector	1	No toggle	0	N/A	Toggle	1
	Reading within Non-Erase Suspend Sector	Data	Data	Data	Data	Data	1
	Erase-Suspend-Program	$\overline{I/O_7}$	Toggle	0	N/A	N/A	0

Notes:

1. I/O7 and I/O2 require a valid address when reading status information. Refer to the appropriate subsection for further details.

2. I/O5 switches to "1" when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. See "I/O5: Exceeded Timing Limits" for more information.

Maximum Negative Input Overshoot
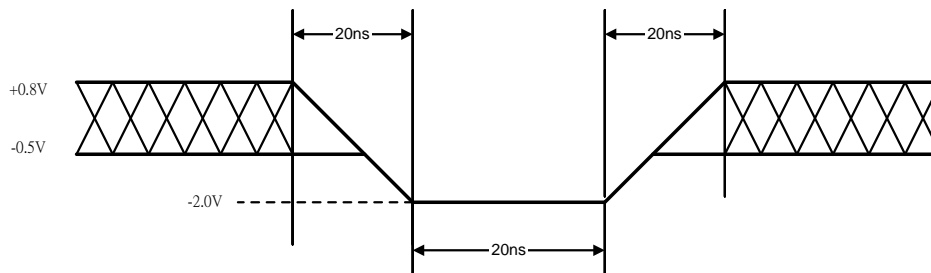
Maximum Positive Input Overshoot
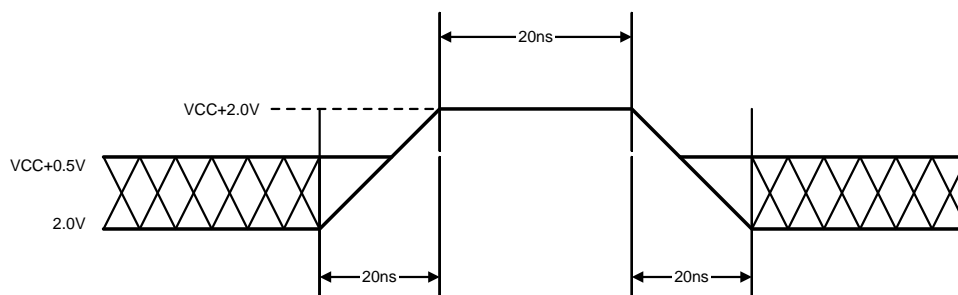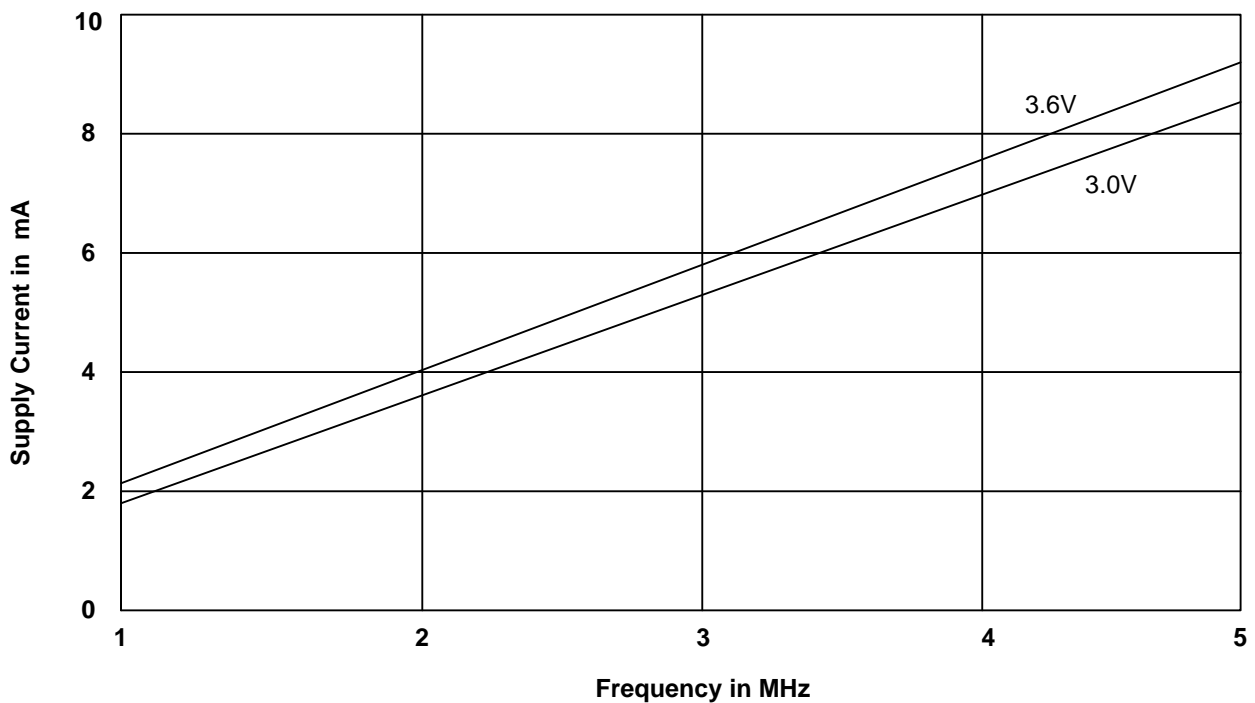
DC Characteristics

CMOS Compatible

Parameter Symbol	Parameter Description	Test Description		Min.	Typ.	Max.	Unit
I_{LI}	Input Load Current	V_{IN} = VSS to VCC. VCC = VCC Max				±1.0	μA
I_{LIT}	A9 Input Load Current	VCC = VCC Max, A9 =12.5V				35	μA
I_{LO}	Output Leakage Current	V_{OUT} = VSS to VCC. VCC = VCC Max				±1.0	μA
I_{CC1}	VCC Active Read Current (Notes 1, 2)	$\overline{CE}$ = V_{IL}, $\overline{OE}$ = V_{IH} Byte Mode	5 MHz		10	16	mA
			1 MHz		2	4	
		$\overline{CE}$ = V_{IL}, $\overline{OE}$ = V_{IH} Word Mode	5 MHz		10	16	
			1 MHz		2	4	
I_{CC2}	VCC Active Write (Program/Erase) Current (Notes 2, 3, 4)	$\overline{CE}$ = V_{IL}, $\overline{OE}$ =V_{IH}			20	30	mA
I_{CC3}	VCC Standby Current (Note 2)	$\overline{CE}$ = $\overline{RESET}$ = VCC ± 0.3V			0.5	5	μA
I_{CC4}	VCC Standby Current During Reset (Note 2)	$\overline{RESET}$= VSS ± 0.3V			0.5	5	μA
I_{CC5}	Automatic Sleep Mode (Note 2, 4, 5)	V_{IH} = VCC ± 0.3V; V_{IL} = VSS ± 0.3V			0.5	5	μA
V_{IL}	Input Low Level			-0.5		0.8	V
V_{IH}	Input High Level			0.7 x VCC		VCC + 0.3	V
V_{HH}	Voltage for $\overline{WP}$/ACC Sector Protect/Unprotect and Program Acceleration	VCC=3.0V ± 10%		11.5		12.5	V
V_{ID}	Voltage for Autoselect and Temporary Unprotect Sector	VCC = 3.0 V ± 10%		11.5		12.5	V
V_{OL}	Output Low Voltage	I_{OL} = 4.0mA, VCC = VCC Min				0.45	V
V_{OH1}	Output High Voltage	I_{OH} = -2.0 mA, VCC = VCC Min		0.85 x VCC			V
V_{OH2}		I_{OH} = -100 μA, VCC = VCC Min		VCC - 0.4			V

Notes:

1. The I_{CC} current listed is typically less than 2 mA/MHz, with $\overline{OE}$ at V_{IH}. Typical VCC is 3.3V.
2. Maximum I_{CC} specifications are tested with VCC = VCC max.
3. I_{CC} active while Embedded Algorithm (program or erase) is in progress.
4. Automatic sleep mode enables the low power mode when addresses remain stable for t_{ACC} + 30ns. Typical sleep mode current is 500nA.
5. Not 100% tested.

DC Characteristics (continued)

Zero Power Flash
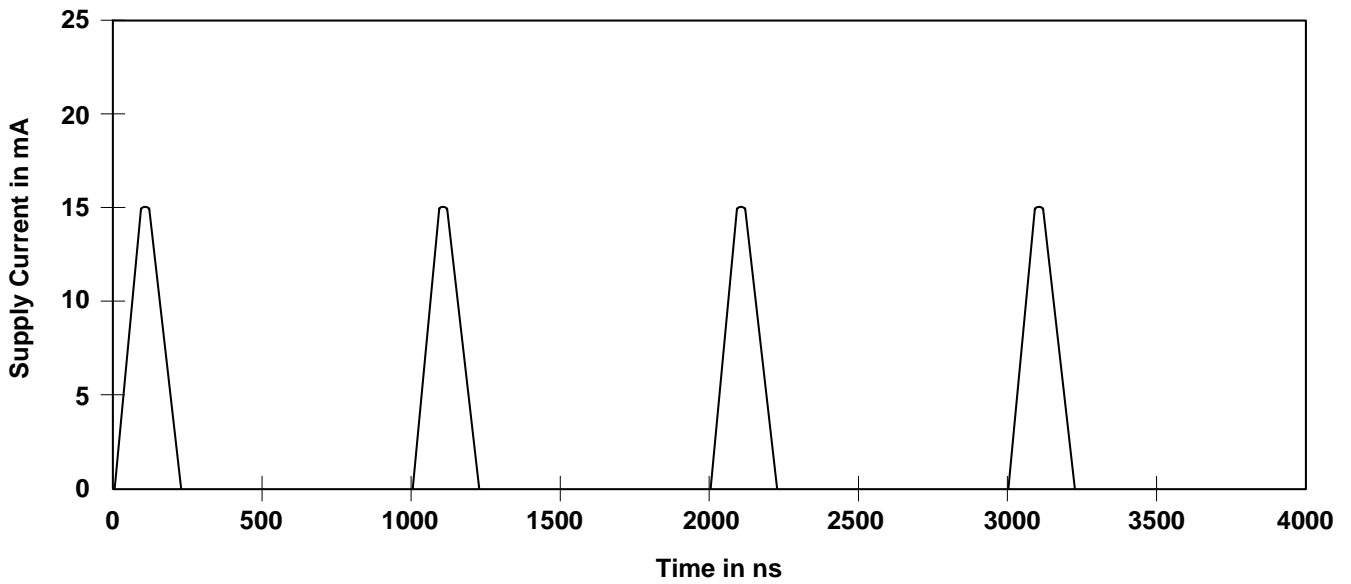
Note: Addresses are switching at 1MHz

ICC1 Current vs. Time (Showing Active and Automatic Sleep Currents)


Note : T = 25°C

Typical ICC1 vs. Frequency

AC Characteristics

Read Only Operations

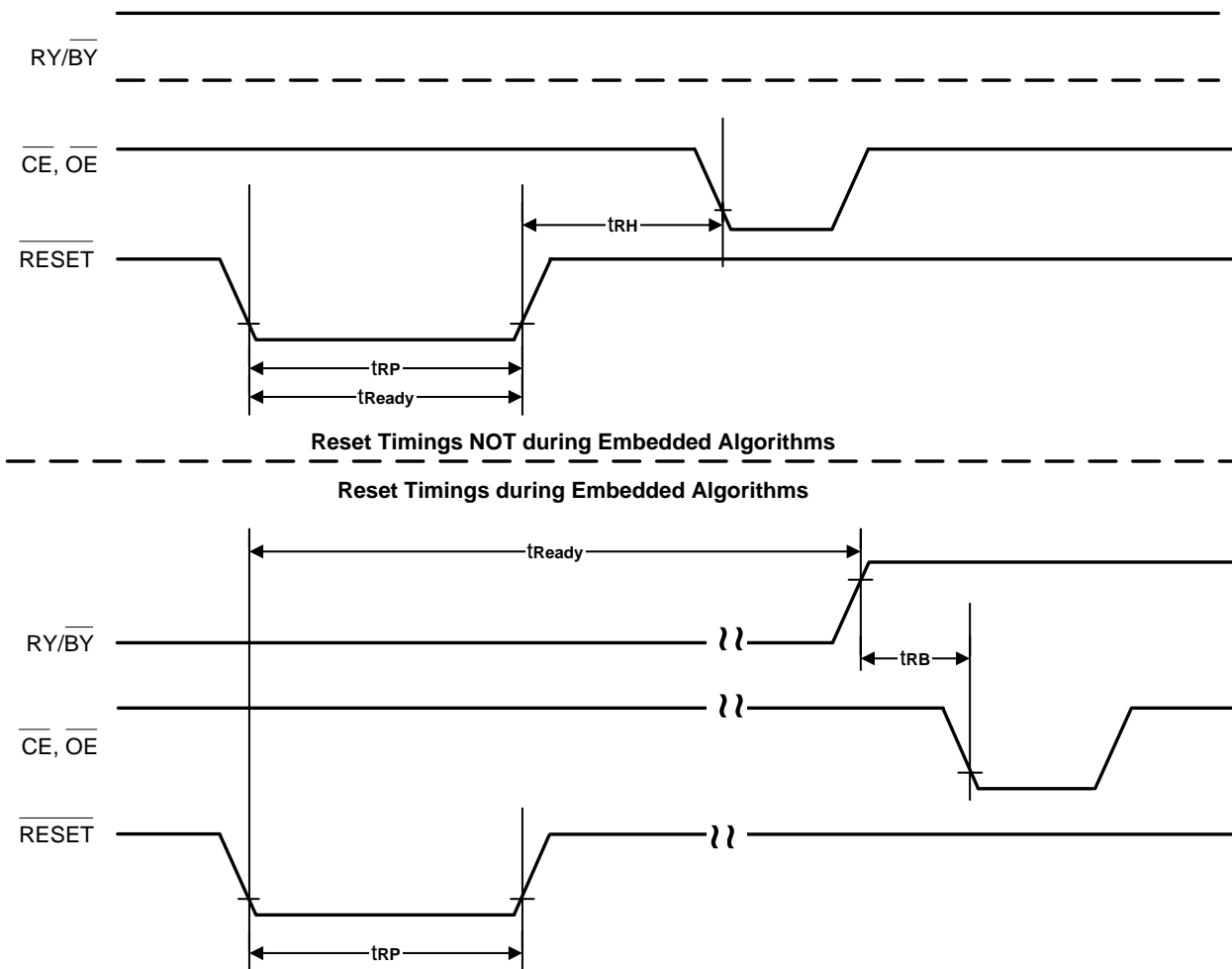| Parameter Symbols		Description	Test Setup		Speed				Unit
JEDEC	Std				-70	-80	-90	-120	
t_{AVAV}	t_{RC}	Read Cycle Time (Note 1)		Min.	70	80	90	120	ns
t_{AVQV}	t_{ACC}	Address to Output Delay	$\overline{CE}$ = V$_{IL}$ $\overline{OE}$ = V$_{IL}$	Max.	70	80	90	120	ns
t_{ELQV}	t_{CE}	Chip Enable to Output Delay	$\overline{OE}$ = V$_{IL}$	Max.	70	80	90	120	ns
t_{GLQV}	t_{OE}	Output Enable to Output Delay		Max.	30	30	40	50	ns
	t_{OEH}	Output Enable Hold Time (Note 1)	Read	0	0	0	0	0	ns
			Toggle and $\overline{Data}$ Polling	10	10	10	10	10	ns
t_{EHQZ}	t_{HZ}	Chip Enable to Output High Z (Notes 1)		Max.	16	16	16	16	ns
t_{GHQZ}	t_{DF}	Output Enable to Output High Z (Notes 1)			16	16	16	16	ns
t_{AXQX}	t_{OH}	Output Hold Time from Addresses, $\overline{CE}$ or $\overline{OE}$, Whichever Occurs First (Note 1)		Min.	0	0	0	0	ns

Notes:

1. Not 100% tested.

2. See Test Conditions and Test Setup for test specifications.

Timing Waveforms for Read Only Operation

AMIC
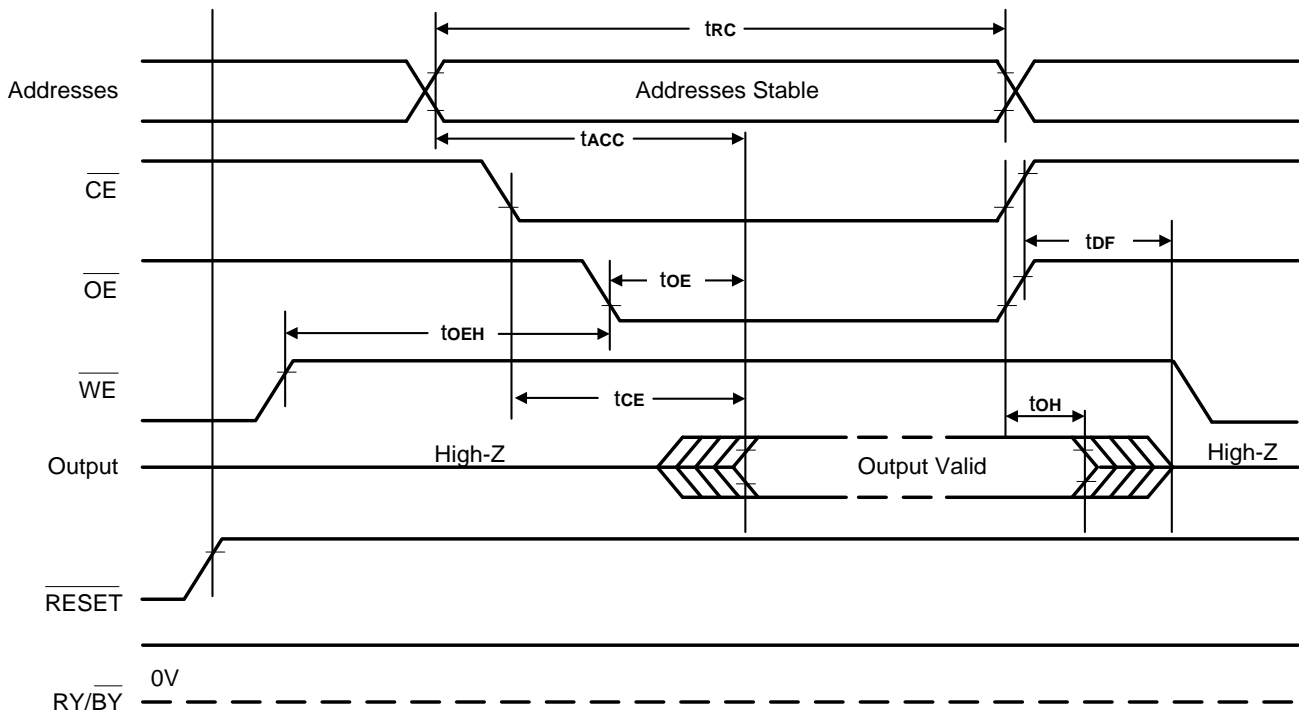
AC Characteristics

Hardware Reset ($\overline{RESET}$)

Parameter		Description	Test Setup		All Speed Options	Unit
JEDEC	Std					
	t$_{READY}$	$\overline{RESET}$ Pin Low (During Embedded Algorithms) to Read or Write (See Note)		Max	20	μs
	t$_{READY}$	$\overline{RESET}$ Pin Low (Not During Embedded Algorithms) to Read or Write (See Note)		Max	500	ns
	t$_{RP}$	$\overline{RESET}$ Pulse Width		Min	500	ns
	t$_{RH}$	$\overline{RESET}$ High Time Before Read (See Note)		Min	50	ns
	t$_{RB}$	RY/$\overline{BY}$ Recovery Time		Min	0	ns
	t$_{RPD}$	$\overline{RESET}$ Low to Standby Mode		Min	20	μs

Note: Not 100% tested.

$\overline{RESET}$ Timings

Reset Timings NOT during Embedded Algorithms

Reset Timings during Embedded Algorithms

Temporary Sector Unprotect

Parameter		Description			All Speed Options	Unit
JEDEC	Std					
	tvIDR	VID Rise and Fall Time (See Note)	Min		500	ns
	tRSP	$\overline{RESET}$ Setup Time for Temporary Sector Unprotect	Min		4	µS
	tVHH	VHH Rise and Fall Time (See Note)	Min		250	ns
	tRRB	$\overline{RESET}$ Hold Time from RY/$\overline{BY}$ High for Temporary Sector/Sector Block Unprotect	Min		4	µS

Note: Not 100% tested.

Temporary Sector Unprotect Timing Diagram
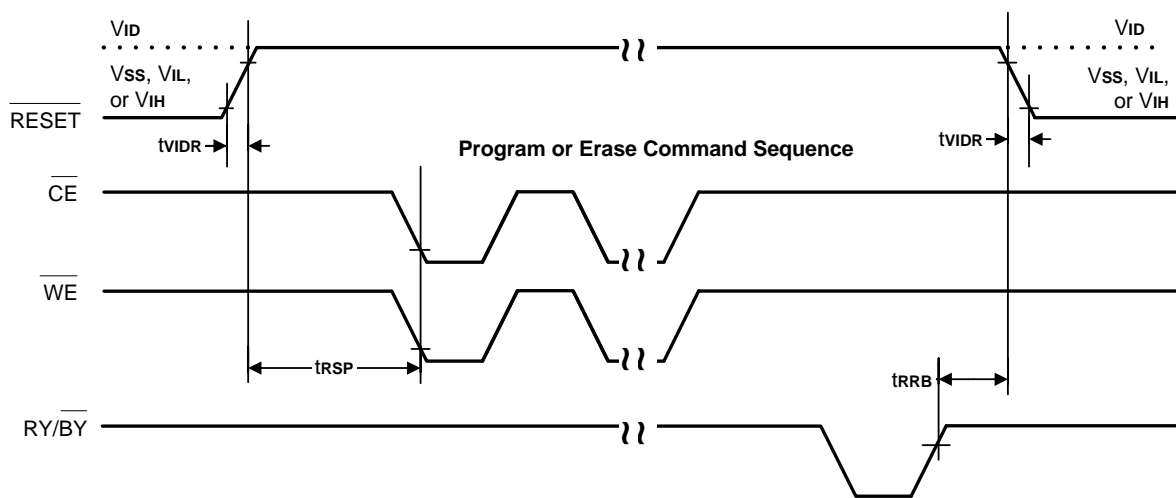
Accelerated Program Timing Diagram
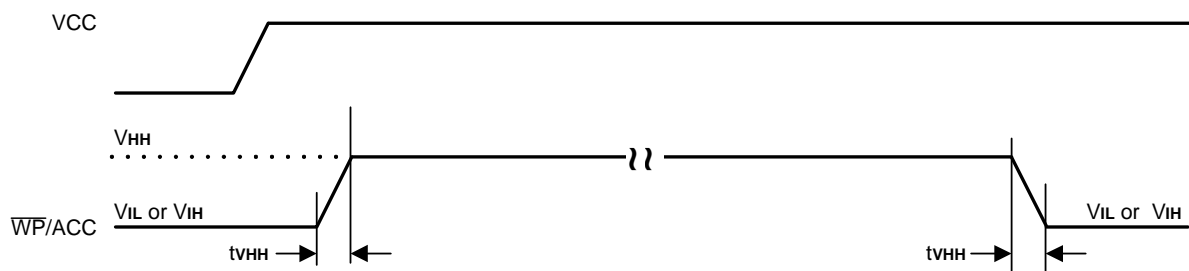
AC Characteristics

Word/Byte Configuration ($\overline{BYTE}$)

Parameter		Description		All Speed Options				Unit
JEDEC	Std			-70	-80	-90	-120	
	tELFL/tELFH	$\overline{CE}$ to $\overline{BYTE}$ Switching Low or High	Max	5				ns
	tFLQZ	$\overline{BYTE}$ Switching Low to Output High-Z	Max	25	25	30	30	ns
	tHQV	$\overline{BYTE}$ Switching High to Output Active	Min	70	80	90	120	ns

$\overline{\text{BYTE}}$ **Timings for Read Operations**
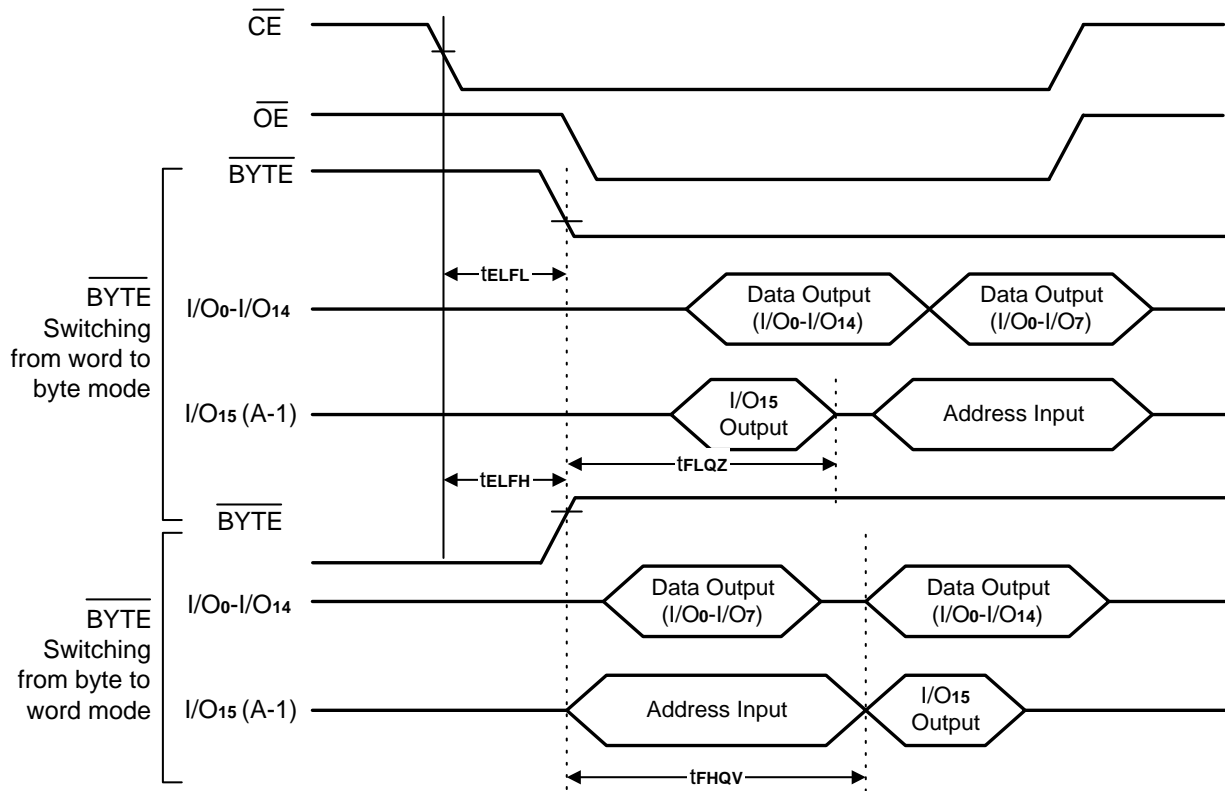
$\overline{\text{BYTE}}$ **Timings for Write Operations**
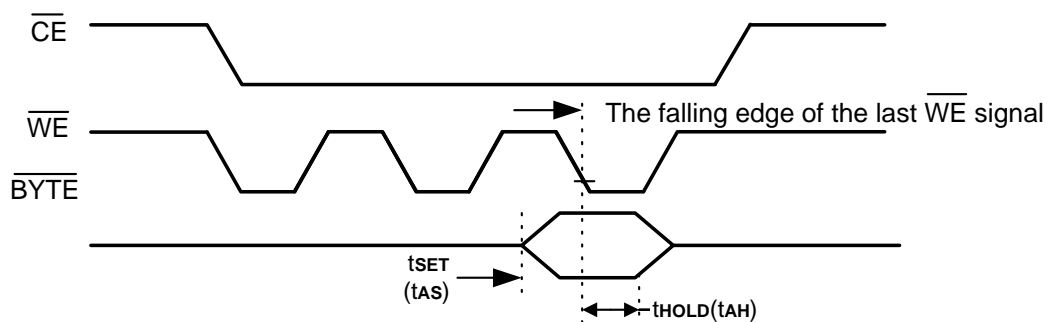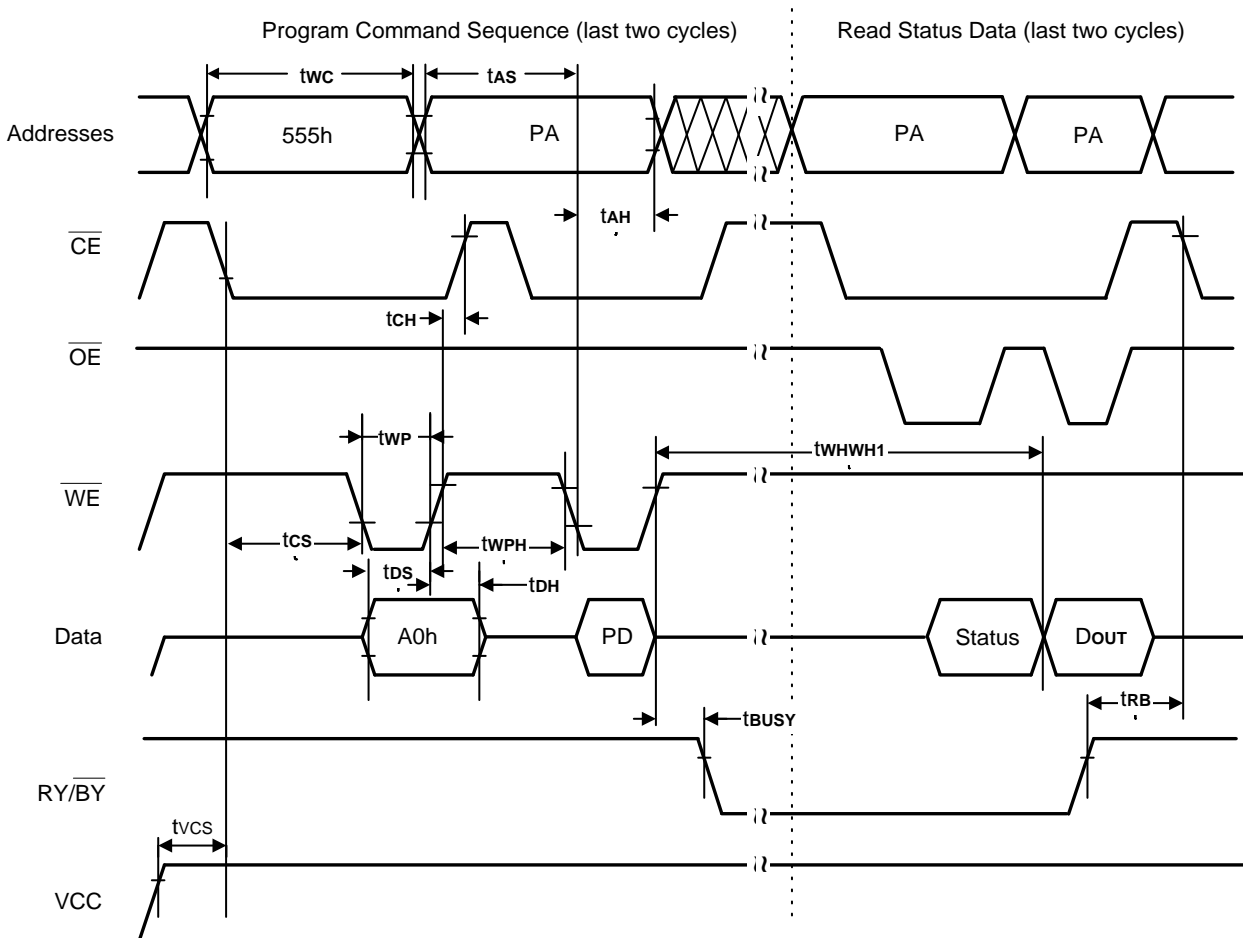

Note:
Refer to the Erase/Program Operations table for t_{AS} and t_{AH} specifications.

AC Characteristics

Erase and Program Operations

Parameter		Description			Speed				Unit
JEDEC	Std				-70	-80	-90	-120	
tAVAV	tWC	Write Cycle Time (Note 1)		Min.	70	80	90	120	ns
tAVWL	tAS	Address Setup Time		Min.	0	0	0	0	ns
tWLAX	tAH	Address Hold Time		Min.	40	45	45	50	ns
tDVWH	tDS	Data Setup Time		Min.	40	45	45	50	ns
tWHDX	tDH	Data Hold Time		Min.	0				ns
	tOES	Output Enable Setup Time		Min.	0				ns
tGHWL	tGHWL	Read Recover Time Before Write ($\overline{OE}$ high to $\overline{WE}$ low)		Min.	0				ns
tELWL	tCS	$\overline{CE}$ Setup Time		Min.	0				ns
tWHEH	tCH	$\overline{CE}$ Hold Time		Min.	0				ns
tWLWH	tWP	Write Pulse Width		Min.	30	35	35	50	ns
tWHWL	tWPH	Write Pulse Width High		Min.	30				ns
tWHWH1	tWHWH1	Byte Programming Operation (Note 2)	Byte	Typ.	20				µs
			Word	Typ.	40				
tWHWH2	tWHWH2	Sector Erase Operation (Note 2)		Typ.	1				sec
	tVCS	VCC Set Up Time (Note 1)		Min.	50				µs
	tRB	Recovery Time from RY/$\overline{BY}$ (Note 1)		Min	0				ns
	tBUSY	Program/Erase Valid to RY/$\overline{BY}$ Delay (Note 1)		Min	90				ns

Notes:

1. Not 100% tested.

2. See the "Erase and Programming Performance" section for more information.

Timing Waveforms for Program Operation

Program Command Sequence (last two cycles)   Read Status Data (last two cycles)

Note :
1. PA = program addrss, PD = program data, Dout is the true data at the program address.
2. Illustration shows device in word mode.

Timing Waveforms for Chip/Sector Erase Operation
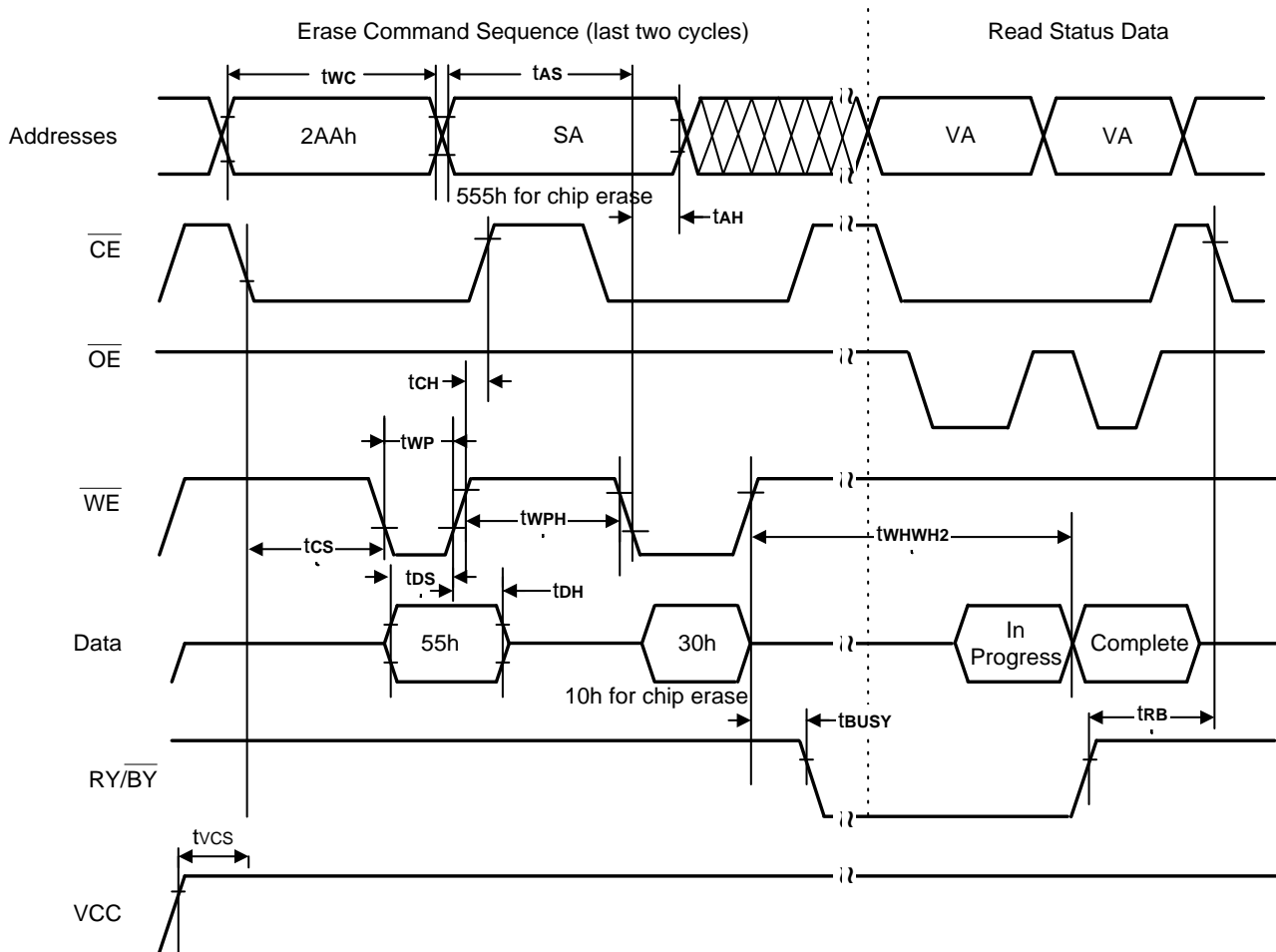
Note :
1. SA = Sector Address (for Sector Erase), VA = Valid Address for reading status data (see "Write Operaion Ststus").
2. Illustratin shows device in word mode.

Timing Waveforms for $\overline{Data}$ Polling (During Embedded Algorithms)
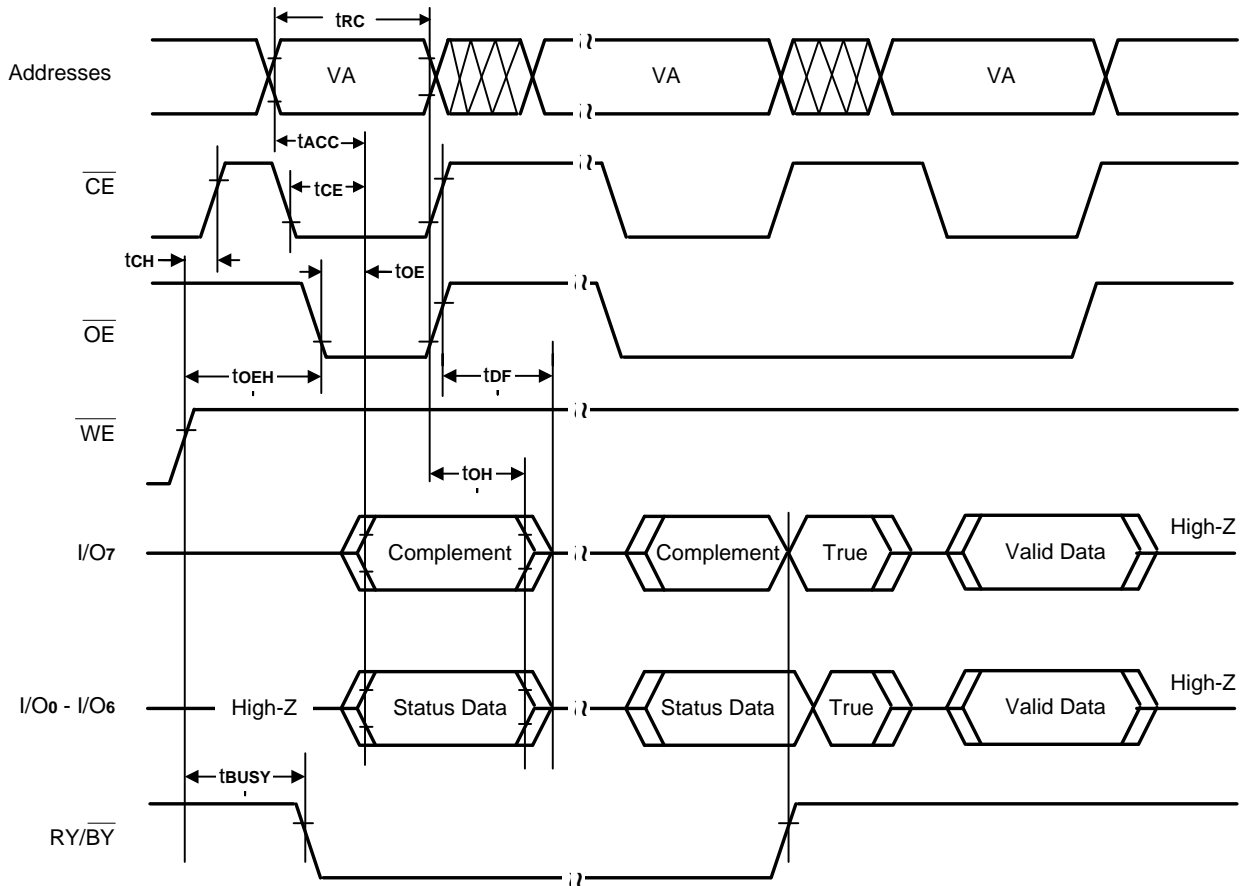

Note : VA = Valid Address. Illustation shows first status cycle after command sequence, last status read cycle, and array data read cycle.

Timing Waveforms for Toggle Bit (During Embedded Algorithms)
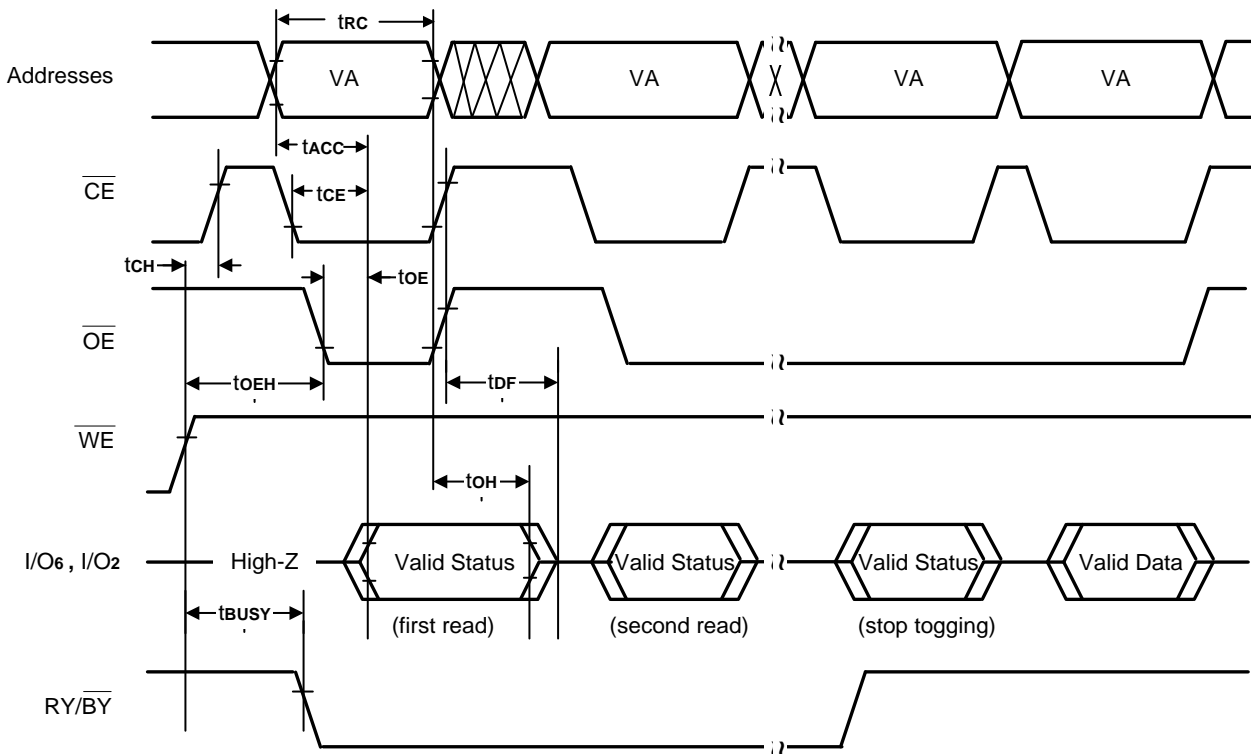
Note: VA = Valid Address; not required for I/O$_6$. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle.

Timing Waveforms for Sector Protect/Unprotect
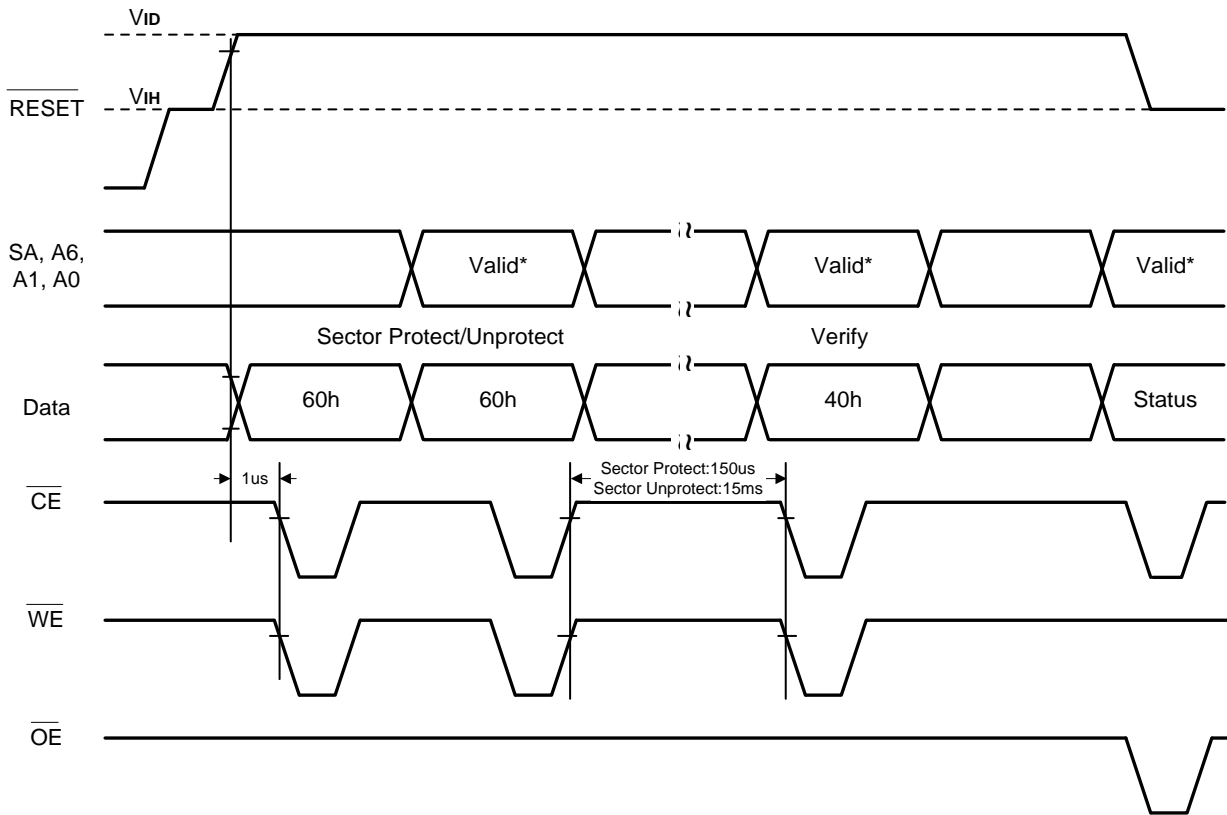
Note : For sector protect, A6=0, A1=1, A0=0. For sector unprotect, A6=1, A1=1, A0=0

Timing Waveforms for I/O₂ vs. I/O₆

I/O$_2$ and I/O$_6$ toggle with $\overline{OE}$ and $\overline{CE}$
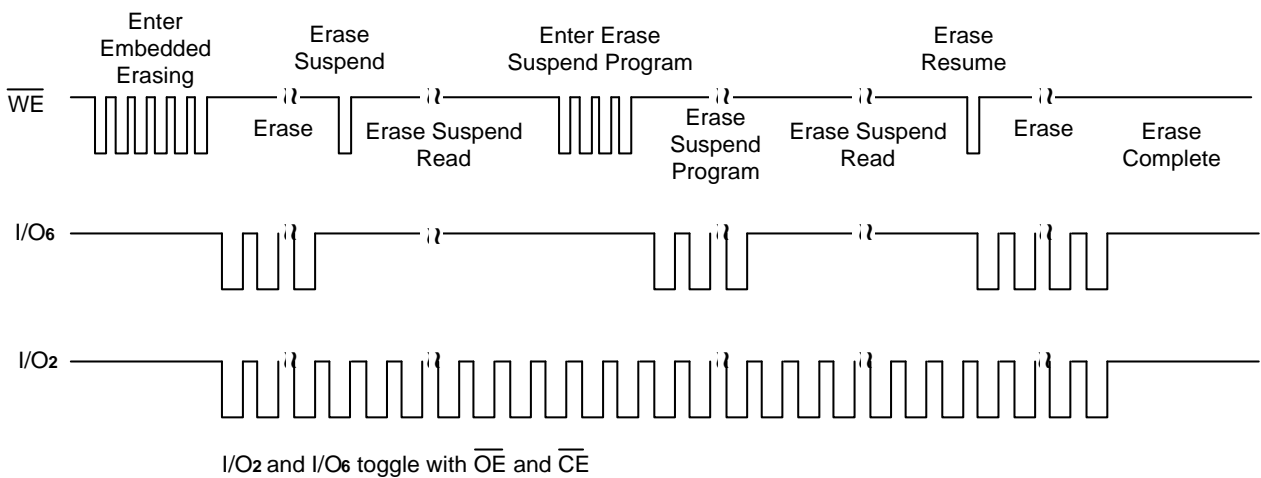
Note : Both I/O$_6$ and I/O$_2$ toggle with $\overline{OE}$ or $\overline{CE}$. See the text on I/O$_6$ and I/O$_2$ in the section "Write Operation Status" for more information.

Timing Waveforms for Alternate $\overline{CE}$ Controlled Write Operation
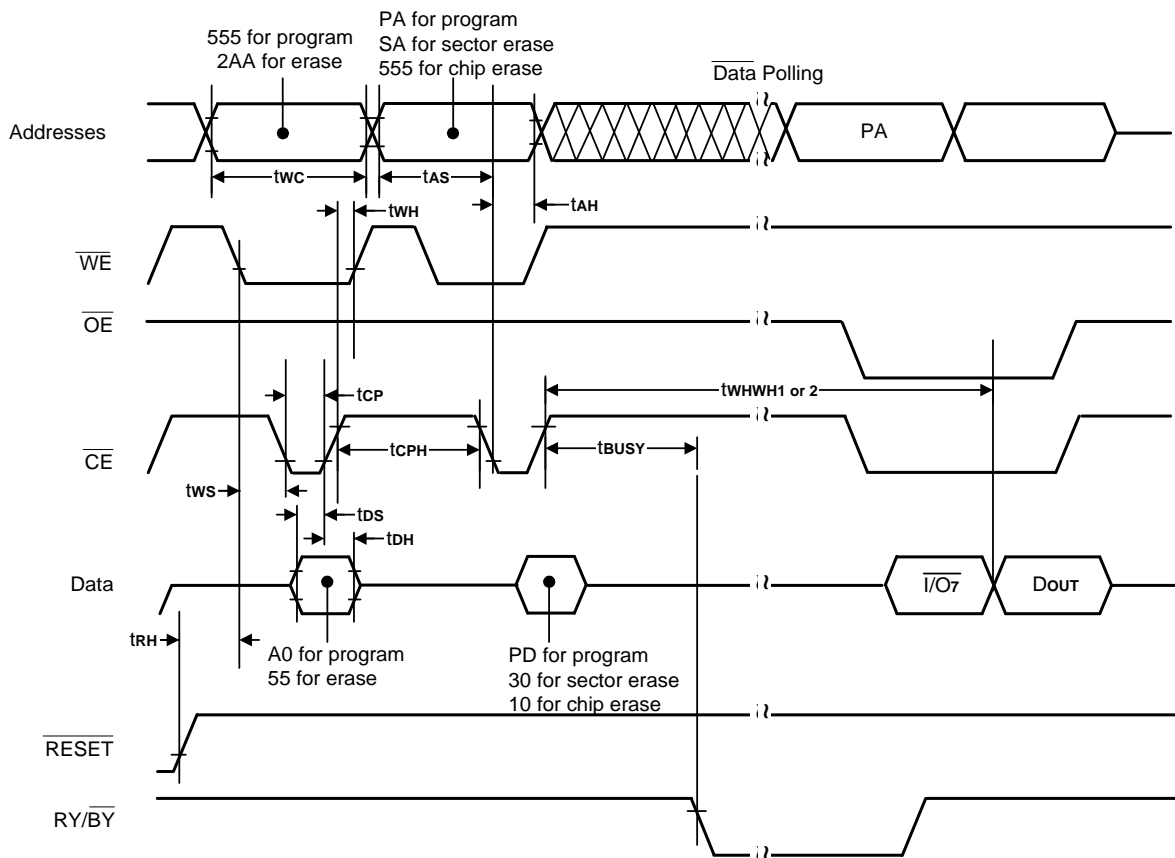
Note :
1. PA = Program Address, PD = Program Data, SA = Sector Address, $\overline{I/O}$ = Complement of Data Input, D$_{OUT}$ = Array Data.
2. Figure indicates the last two bus cycles of the command sequence.

Erase and Programming Performance

Parameter		Typ. (Note 1)	Unit	Comments
Sector Erase Time		1.0	sec	Excludes 00h programming prior to erasure
Chip Erase Time		45	sec	
Byte Programming Time		20	μs	
Word Programming Time		40	μs	Excludes system-level overhead (Note 4)
Chip Programming Time (Note 2)	Byte Mode	32	sec	
	Word Mode	20	sec	

Notes:
1. Typical program and erase times assume the following conditions: 25°C, 3.0V VCC, 10,000 cycles. Additionally, programming typically assumes checkerboard pattern.
2. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum byte program time listed. If the maximum byte program time given is exceeded, only then does the device set I/O$_5$ = 1. See the section on I/O$_5$ for further information.
3. In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.
4. System-level overhead is the time required to execute the four-bus-cycle command sequence for programming. See Table 9 for further information on command definitions.
5. The device has a guaranteed minimum erase and program cycle endurance of 100,000 cycles.

Latch-up Characteristics

Description	Min.	Max.
Input Voltage with respect to VSS on all I/O pins	-1.0V	VCC+1.0V
VCC Current	-100 mA	+100 mA
Input voltage with respect to VSS on all pins except I/O pins (including A9, $\overline{OE}$ and $\overline{RESET}$)	-1.0V	12.5V

Includes all pins except VCC. Test conditions: VCC = 5.0V, one pin at time.

TSOP/TFBGA Pin Capacitance

Parameter Symbol	Parameter Description	Test Setup		Typ.	Max.	Unit
C_{IN}	Input Capacitance	$V_{IN}=0$	TSOP	6	7.5	pF
			TFBGA	4.2	5	pF
C_{OUT}	Output Capacitance	$V_{OUT}=0$	TSOP	8.5	12	pF
			TFBGA	5.4	6.5	pF
C_{IN2}	Control Pin Capacitance	$V_{IN}=0$	TSOP	7.5	9	pF
			TFBGA	3.9	4.7	pF

Notes:

1. Sampled, not 100% tested.

2. Test conditions $T_A = 25°C$, f = 1.0MHz

Data Retention

Parameter	Test Conditions	Min	Unit
Minimum Pattern Data Retention Time	150°C	10	Years
	125°C	20	Years

Test Conditions

Test Specifications

Test Condition	-70	-80	-90	-120	Unit
Output Load	1 TTL gate				
Output Load Capacitance, C$_L$(including jig capacitance)	30	100	100	100	pF
Input Rise and Fall Times	5				ns
Input Pulse Levels	0.0 – VCC				V
Input timing measurement reference levels	0.5VCC				V
Output timing measurement reference levels	0.5VCC				V

Test Setup

Device Under Test

3.0V

2.7 KW

C$_L$ 6.2 KW

Diodes = IN3064 or Equivalent
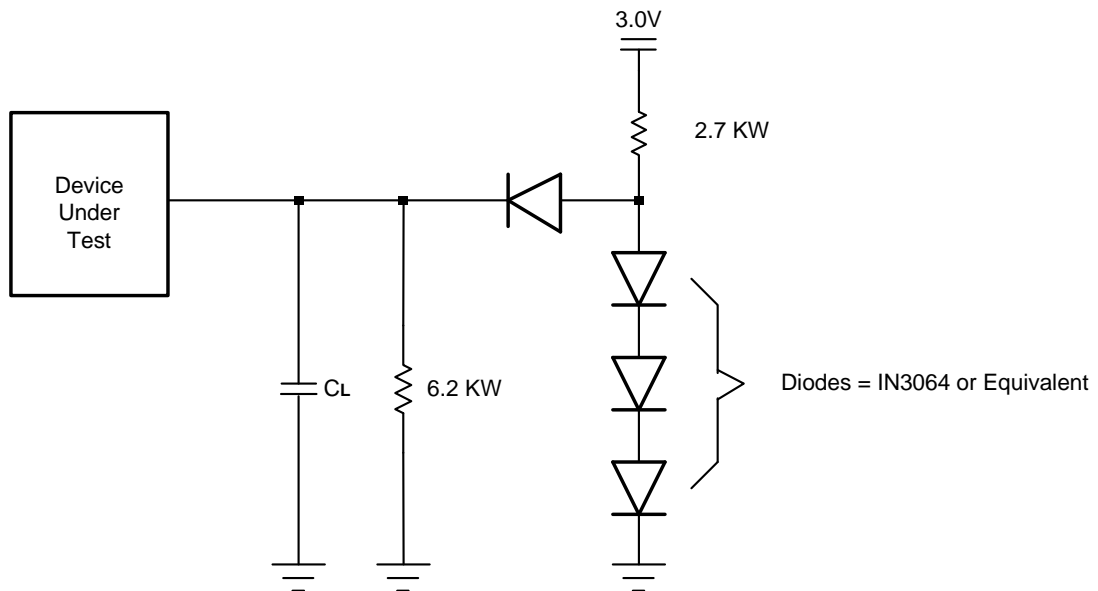
Input Waveforms and Measurement Levels

VCC

Input   0.5VCC   ◄— Measurement Level —►   0.5VCC   Output

0.0V

AMIC
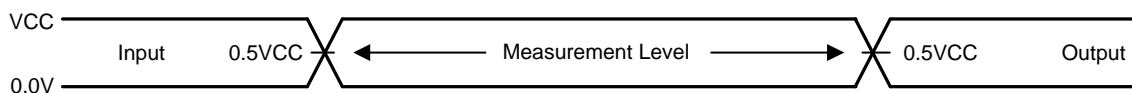
Ordering Information

Top Boot Sector Flash

Part No.	Access Time (ns)	Active Read Current Typ. (mA)	Program/Erase Current Typ. (mA)	Standby Current Typ. (μA)	Package
A29L320ATV-70F	70	10	20	0.5	48 Pin Pb-Free TSOP
A29L320ATV-70UF					48 Pin Pb-Free TSOP
A29L320ATV-70IF					48 Pin Pb-Free TSOP
A29L320ATG-70F					48 ball Pb-Free TFBGA
A29L320ATG-70UF					48 ball Pb-Free TFBGA
A29L320ATG-70IF					48 ball Pb-Free TFBGA
A29L320ATV-80F	80	10	20	0.5	48 Pin Pb-Free TSOP
A29L320ATV-80UF					48 Pin Pb-Free TSOP
A29L320ATV-80IF					48 Pin Pb-Free TSOP
A29L320ATG-80F					48 ball Pb-Free TFBGA
A29L320ATG-80UF					48 ball Pb-Free TFBGA
A29L320ATG-80IF					48 ball Pb-Free TFBGA
A29L320ATV-90F	90	10	20	0.5	48 Pin Pb-Free TSOP
A29L320ATV-90UF					48 Pin Pb-Free TSOP
A29L320ATV-90IF					48 Pin Pb-Free TSOP
A29L320ATG-90F					48 ball Pb-Free TFBGA
A29L320ATG-90UF					48 ball Pb-Free TFBGA
A29L320ATG-90IF					48 ball Pb-Free TFBGA
A29L320ATV-120F	120	10	20	0.5	48 Pin Pb-Free TSOP
A29L320ATV-120UF					48 Pin Pb-Free TSOP
A29L320ATV-120IF					48 Pin Pb-Free TSOP
A29L320ATG-120F					48 ball Pb-Free TFBGA
A29L320ATG-120UF					48 ball Pb-Free TFBGA
A29L320ATG-120IF					48 ball Pb-Free TFBGA

Note: -U is for industrial operating temperature range: -40°C to +85°C

-I is for industrial operating temperature range: -25°C to +85°C

Ordering Information (continued)

Bottom Boot Sector Flash

Part No.	Access Time (ns)	Active Read Current Typ. (mA)	Program/Erase Current Typ. (mA)	Standby Current Typ. (μA)	Package
A29L320AUV-70F	70	10	20	0.5	48 Pin Pb-Free TSOP
A29L320AUV-70UF					48 Pin Pb-Free TSOP
A29L320AUV-70IF					48 Pin Pb-Free TSOP
A29L320AUG-70F					48 ball Pb-Free TFBGA
A29L320AUG-70UF					48 ball Pb-Free TFBGA
A29L320AUG-70IF					48 ball Pb-Free TFBGA
A29L320AUV-80F	80	10	20	0.5	48 Pin Pb-Free TSOP
A29L320AUV-80UF					48 Pin Pb-Free TSOP
A29L320AUV-80IF					48 Pin Pb-Free TSOP
A29L320AUG-80F					48 ball Pb-Free TFBGA
A29L320AUG-80UF					48 ball Pb-Free TFBGA
A29L320AUG-80IF					48 ball Pb-Free TFBGA
A29L320AUV-90F	90	10	20	0.5	48 Pin Pb-Free TSOP
A29L320AUV-90UF					48 Pin Pb-Free TSOP
A29L320AUV-90IF					48 Pin Pb-Free TSOP
A29L320AUG-90F					48 ball Pb-Free TFBGA
A29L320AUG-90UF					48 ball Pb-Free TFBGA
A29L320AUG-90IF					48 ball Pb-Free TFBGA
A29L320AUV-120F	120	10	20	0.5	48 Pin Pb-Free TSOP
A29L320AUV-120UF					48 Pin Pb-Free TSOP
A29L320AUV-120IF					48 Pin Pb-Free TSOP
A29L320AUG-120F					48 ball Pb-Free TFBGA
A29L320AUG-120UF					48 ball Pb-Free TFBGA
A29L320AUG-120IF					48 ball Pb-Free TFBGA

Note: -U is for industrial operating temperature range: -40°C to +85°C

-I is for industrial operating temperature range: -25°C to +85°C

Package Information

**TSOP 48L (Type I) Outline Dimensions**   unit: inches/mm

Detail "A"

Detail "A"
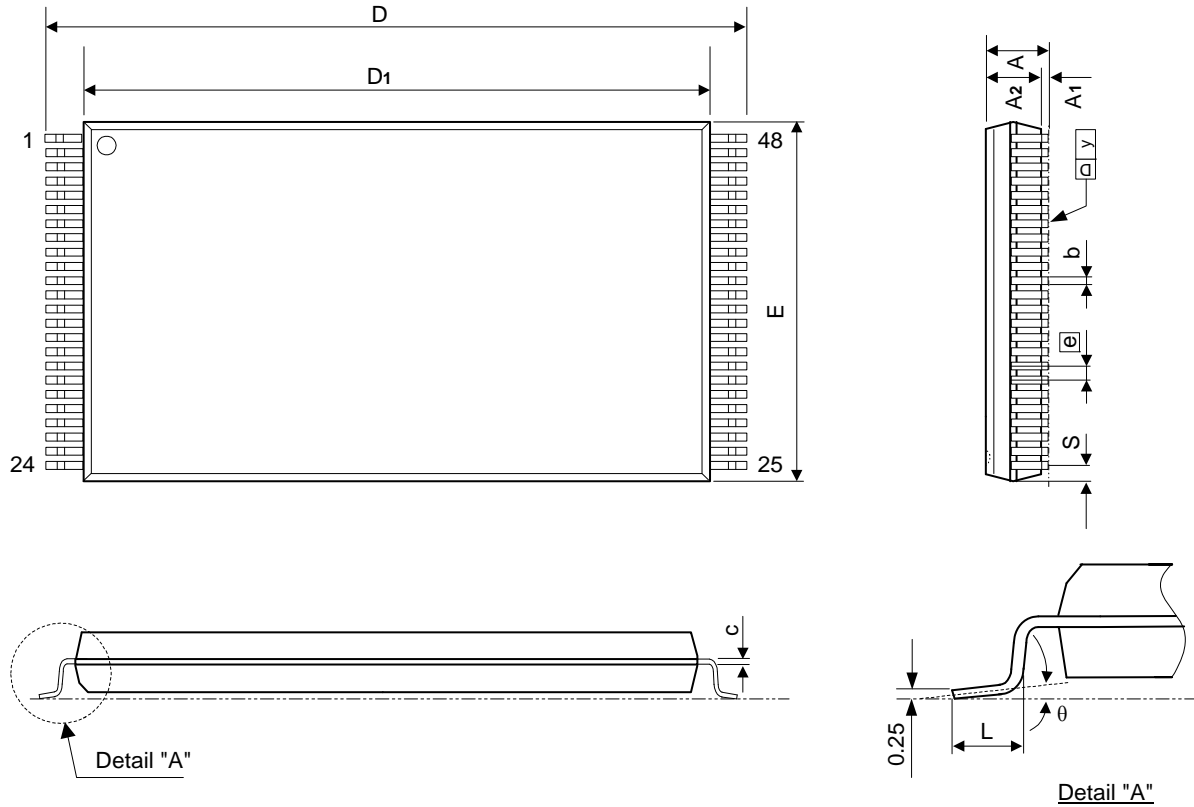
Symbol	Dimensions in inches			Dimensions in mm		
	Min	Nom	Max	Min	Nom	Max
A	-	-	0.047	-	-	1.20
A1	0.002	-	0.006	0.05	-	0.15
A2	0.037	0.039	0.042	0.94	1.00	1.06
b	0.007	0.009	0.011	0.18	0.22	0.27
c	0.004	-	0.008	0.12	-	0.20
D	0.779	0.787	0.795	19.80	20.00	20.20
D1	0.720	0.724	0.728	18.30	18.40	18.50
E	-	0.472	0.476	-	12.00	12.10
e	0.020 BASIC			0.50 BASIC		
L	0.020	0.024	0.0275	0.50	0.60	0.70
S	0.011 Typ.			0.28 Typ.		
y	-	-	0.004	-	-	0.10
θ	0°	-	8°	0°	-	8°

Notes:
1. The maximum value of dimension D includes end flash.
2. Dimension E does not include resin fins.
3. Dimension S includes end flash.

Package Information

48LD CSP (6 x 8 mm) Outline Dimensions   unit: mm
(48TFBGA)

TOP VIEW

BOTTOM VIEW

Ball*A1 CORNER

⌀ b

SIDE VIEW

SEATING PLANE

0.10 C
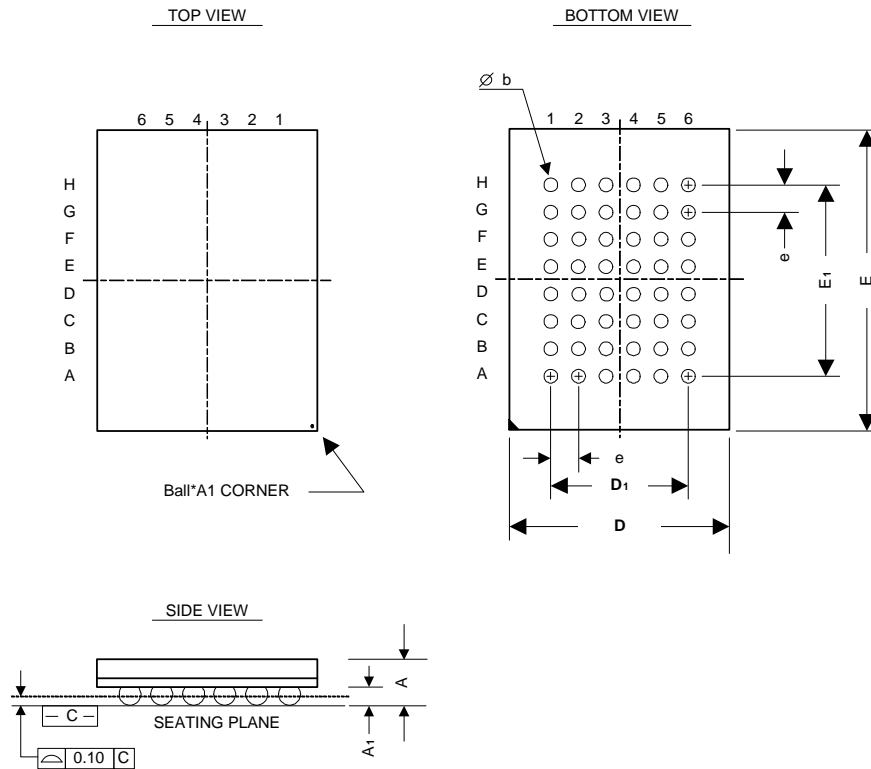
Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A	-	-	1.20
A$_1$	0.20	0.25	0.30
b	0.30	-	0.40
D	5.90	6.00	6.10
D$_1$	4.00 BSC		
e	-	0.80	-
E	7.90	8.00	8.10
E$_1$	5.60 BSC		